DSA8300 Digital Serial Analyzer Quick Start User Manual





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For product information, sales, service, and technical support:

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- Worldwide, visit www.tektronix.com to find contacts in your area.

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Tektronix warrants that this product will be free from defects in materials and workmanship for a period of three (3) years from the date of shipment. If any such product proves defective during this warranty period, Tektronix, at its option, either will repair the defective product without charge for parts and labor, or will provide a replacement in exchange for the defective product. Parts, modules and replacement products used by Tektronix for warranty work may be new or reconditioned to like new performance. All replaced parts, modules and products become the property of Tektronix.

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Table of Contents

General Safety Summary	iii
Compliance Information	۷
EMC Compliance	v
Safety Compliance	vii
Environmental Considerations	ix
Preface	х
Documentation	х
Conventions Used in This Manual	Х
Key Features	1
Install Your Instrument	3
Standard Accessories	3
Operating Considerations	4
Installing Modules	6
Powering the Instrument On and Off	7
Adding a Second Monitor	7
	10
	10
	11
	12
	13
·	14
	15
	16
	17
•	18
	18
	20
	20
÷ .	23
	25
·	25 25
	23 27
• • •	21
5	
	29
	30
	32
	33
	35
	35
	38
5 <i>,</i>	39
Checking Trigger Status	40

Waveform Measurements	41
Taking Automatic Measurements	41
Turning Off Automatic Measurements	45
Cursor Measurements	46
Math Waveforms	48
Display a Communication Signal	49
Mask Testing	51
FrameScan	54
To Use TDR	55
Phase Reference	57
Histograms	59
Document Your Results	60
Skew and Deskewing	61
Methods to Adjust Skew	62
Setup Considerations and Procedures	62
Acquisition Deskew Procedure	66
TDR Step Deskew Procedure	69
Cleaning the Instrument	73
Exterior Cleaning	73
Flat Panel Display Cleaning	73
Optical Connector Cleaning	73
Restoring the Operating System	74
Restoring the Operating System from the Instrument Hard Disk Drive	74
Restoring the Operating System with Restore Media	75
Index	

General Safety Summary

Review the following safety precautions to avoid injury and prevent damage to this product or any products connected to it.

To avoid potential hazards, use this product only as specified.

Only qualified personnel should perform service procedures.

While using this product, you may need to access other parts of a larger system. Read the safety sections of the other component manuals for warnings and cautions related to operating the system.

To Avoid Fire or Personal Injury

Use proper power cord. Use only the power cord specified for this product and certified for the country of use.

Connect and disconnect properly. Do not connect or disconnect probes or test leads while they are connected to a voltage source.

Ground the product. This product is grounded through the grounding conductor of the power cord. To avoid electric shock, the grounding conductor must be connected to earth ground. Before making connections to the input or output terminals of the product, ensure that the product is properly grounded.

Observe all terminal ratings. To avoid fire or shock hazard, observe all ratings and markings on the product. Consult the product manual for further ratings information before making connections to the product.

The inputs are not rated for connection to mains or Category II, III, or IV circuits.

Do not apply a potential to any terminal, including the common terminal, that exceeds the maximum rating of that terminal.

Power disconnect. The power switch disconnects the product from the power source. See instructions for the location. Do not block the power switch; it must remain accessible to the user at all times.

Do not operate without covers. Do not operate this product with covers or panels removed.

Do not operate with suspected failures. If you suspect that there is damage to this product, have it inspected by qualified service personnel.

Avoid exposed circuitry. Do not touch exposed connections and components when power is present.

Use proper fuse. Use only the fuse type and rating specified for this product.

Wear eye protection. Wear eye protection if exposure to high-intensity rays or laser radiation exists.

Do not operate in wet/damp conditions.

Do not operate in an explosive atmosphere.

Keep product surfaces clean and dry.

Provide proper ventilation. Refer to the manual's installation instructions for details on installing the product so it has proper ventilation.

Terms in This Manual

These terms may appear in this manual:



WARNING. Warning statements identify conditions or practices that could result in injury or loss of life.



CAUTION. Caution statements identify conditions or practices that could result in damage to this product or other property.

Symbols and Terms on the Product

These terms may appear on the product:

- DANGER indicates an injury hazard immediately accessible as you read the marking.
- WARNING indicates an injury hazard not immediately accessible as you read the marking.
- CAUTION indicates a hazard to property including the product.

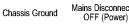
The following symbol(s) may appear on the product:





High Voltage (Earth) Terminal





ON (Power)



Compliance Information

This section lists the EMC (electromagnetic compliance), safety, and environmental standards with which the instrument complies.

EMC Compliance

EC Declaration of Conformity – EMC

Meets intent of Directive 2004/108/EC for Electromagnetic Compatibility. Compliance was demonstrated to the following specifications as listed in the Official Journal of the European Communities:

EN 61326-1:2006, EN 61326-2-1:2006. EMC requirements for electrical equipment for measurement, control, and laboratory use. ¹ ² ³ ⁶

- CISPR 11:2003. Radiated and conducted emissions, Group 1, Class A
- IEC 61000-4-2:2001. Electrostatic discharge immunity
- IEC 61000-4-3:2002. RF electromagnetic field immunity 4
- IEC 61000-4-4:2004. Electrical fast transient / burst immunity
- IEC 61000-4-5:2001. Power line surge immunity
- IEC 61000-4-6:2003. Conducted RF immunity
- IEC 61000-4-11:2004. Voltage dips and interruptions immunity ⁵

EN 61000-3-2:2006. AC power line harmonic emissions

EN 61000-3-3:1995. Voltage changes, fluctuations, and flicker

European contact.

Tektronix UK, Ltd. Western Peninsula Western Road Bracknell, RG12 1RF United Kingdom

- ¹ This product is intended for use in nonresidential areas only. Use in residential areas may cause electromagnetic interference.
- ² Emissions which exceed the levels required by this standard may occur when this equipment is connected to a test object.
- ³ To ensure compliance with the EMC standards listed here, use high quality shielded interface cables.
- ⁴ Horizontal timing susceptibility of the optical sampling modules and their internal clock recovery trigger signals usually increases the horizontal timing jitter when external electromagnetic fields are applied. For fields up to 3 V/m, the increase in the horizontal high-frequency RMS jitter is typically less than 3 ps RMS of jitter, added using the square-root-of-the-sum-of-the-squares method. For example, if an 80C01–CR operating in clock-recovery trigger mode exhibits 3.5 ps RMS of edge jitter, with no EMC field applied and for an ideal jitterless input, then for applied fields up to 3 V/m the edge jitter, degradation would typically result in a total RMS jitter of:

$$Jitter \ \le \ \sqrt{3.5 \ ps^{\ 2} \ + \ 3 \ ps^{\ 2}} \ = \ 4.61 \ ps$$

- ⁵ Performance Criterion C applied at the 70%/25 cycle Voltage-Dip and the 0%/250 cycle Voltage-Interruption test levels (IEC 61000-4-11). If the instrument powers down upon a voltage dip or interruption, it will take longer than ten seconds to reboot.
- ⁶ With an 80E01 Electrical Sampling module, up to 15 mV_{RMS} random noise is allowed when the instrument is subjected to fields and signals as defined in the IEC 61000-4-3 and IEC 61000-4-6 tests.

Australia / New Zealand Declaration of Conformity - EMC

Complies with the EMC provision of the Radiocommunications Act per the following standard, in accordance with ACMA:

 CISPR 11:2003. Radiated and Conducted Emissions, Group 1, Class A, in accordance with EN 61326-1:2006 and EN 61326-2-1:2006.

Safety Compliance

EC Declaration of Conformity – Low Voltage

Compliance was demonstrated to the following specification as listed in the Official Journal of the European Communities:

Low Voltage Directive 2006/95/EC.

EN 61010-1: 2001. Safety requirements for electrical equipment for measurement control and laboratory use.

U.S. Nationally Recognized Testing Laboratory Listing

UL61010-1, 2nd Edition. Safety requirements for electrical equipment for measurement, control, and laboratory use-Part 1.

Canadian Certification

CAN/CSA-C22.2 No. 61010-1-2004. Safety requirements for electrical equipment for measurement, control, and laboratory use- Part 1

Additional Compliances

■ IEC 61010-1: 2001. Safety requirements for electrical equipment for measurement, control, and laboratory use.

Equipment Type

Test and measuring equipment.

Safety Class

Class 1 - grounded product.

Pollution Degree Description

A measure of the contaminants that could occur in the environment around and within a product. Typically the internal environment inside a product is considered to be the same as the external. Products should be used only in the environment for which they are rated.

- Pollution Degree 1. No pollution or only dry, nonconductive pollution occurs. Products in this category are generally encapsulated, hermetically sealed, or located in clean rooms.
- Pollution Degree 2. Normally only dry, nonconductive pollution occurs. Occasionally a temporary conductivity that is caused by condensation must be expected. This location is a typical office/home environment. Temporary condensation occurs only when the product is out of service.
- Pollution Degree 3. Conductive pollution, or dry, nonconductive pollution that becomes conductive due to condensation. These are sheltered locations where neither temperature nor humidity is controlled. The area is protected from direct sunshine, rain, or direct wind.
- Pollution Degree 4. Pollution that generates persistent conductivity through conductive dust, rain, or snow. Typical outdoor locations.

Pollution Degree

Pollution Degree 2 (as defined in IEC 61010-1). Note: Rated for indoor use only.

Installation (Overvoltage) Category Descriptions

Terminals on this product may have different installation (overvoltage) category designations. The installation categories are:

- Measurement Category IV. For measurements performed at the source of low-voltage installation.
- Measurement Category III. For measurements performed in the building installation.
- Measurement Category II. For measurements performed on circuits directly connected to the low-voltage installation.
- Measurement Category I. For measurements performed on circuits not directly connected to MAINS.

Overvoltage Category

Overvoltage Category II (as defined in IEC 61010-1)

Environmental Considerations

This section provides information about the environmental impact of the product.

Product End-of-Life Handling

Observe the following guidelines when recycling an instrument or component:

Equipment recycling. Production of this equipment required the extraction and use of natural resources. The equipment may contain substances that could be harmful to the environment or human health if improperly handled at the product's end of life. In order to avoid release of such substances into the environment and to reduce the use of natural resources, we encourage you to recycle this product in an appropriate system that will ensure that most of the materials are reused or recycled appropriately.



This symbol indicates that this product complies with the applicable European Union requirements according to Directives 2002/96/EC and 2006/66/EC on waste electrical and electronic equipment (WEEE) and batteries. For information about recycling options, check the Support/Service section of the Tektronix Web site (www.tektronix.com).

Perchlorate materials. This product contains one or more type CR lithium batteries. According to the state of California, CR lithium batteries are classified as perchlorate materials and require special handling. See www.dtsc.ca.gov/hazardouswaste/perchlorate for additional information.

Restriction of Hazardous Substances

This product has been classified as Monitoring and Control equipment, and is outside the scope of the 2002/95/EC RoHS Directive.

Preface

Documentation

This manual describes the installation and operation of the DSA8300 Digital Serial Analyzer including basic operation and concepts. For more detailed information, see the online help on your instrument.

NOTE. The screen images in this manual may differ slightly from other versions of product software.

Additional information is available through a variety of sources. The following table points to the location of different types of information available for this product.

Type of information	Location	
Unpacking, installation, operation and overviews	Quick Start User Manual	
In-depth operation, UI help, programming help	Instrument online help	
Performance verification and specifications	Product documentation CD	
Product software	Product software CD	
	www.tektronix.com/software	
Service	Service manual	
PDF files of instrument and modules manuals	Product software CD	
	www.tektronix.com/manuals	

Conventions Used in This Manual

The following icons may be used in this manual.

Rear panel power

Front panel power



Network

PS2

USB













Key Features

The DSA8300 is a state-of-the-art equivalent time sampling oscilloscope that provides the highest fidelity measurement and analysis capabilities for communications signal analysis, serial data network analysis, and serial data link analysis applications.

Highest Fidelity Signal Capture

- Very Low Time-base Jitter:
 - = 425 fs typical on up to 8 simultaneously acquired channels
 - = <200 fs typical on up to 6 channels with 82A04 phase reference module</p>
- Best vertical resolution (16 bit A/D):
 - = Electrical resolution: <20 μV LSB (for 1 Vfull range)
 - Optical resolution depends on the dynamic range of the optical module ranges from <20 nW for the 80C07b (1 mW full range) to <0.6 µW for the 80C10b (30 mW full range)

Flexible Configurations

- The DSA8300 supports up to 8 simultaneously acquired signals
- A wide variety of optical, electrical, and accessory modules to support your specific testing requirements

Optical Modules

- Fully integrated optical modules that support all standard optical data rates from 155 Mb/s to 100 Gb/s
- Certified optical reference receivers support specified requirements for standards-mandated compliance testing
- Optical bandwidths to >80 Ghz
- High optical sensitivity and low noise as well as the wide dynamic range of the optical sampling modules allows accurate testing and characterization of short-reach to long-haul optical communications standards
- Fully calibrated clock recovery solutions; no need to manually calibrate for data pick-off losses
- Calibrated extinction ratio measurements ensure repeatability of extinction ratio measurements to <0.5 dB among systems with modules with this factory calibration option</p>

Electrical Modules

- Electrical bandwidths to >70 Ghz
- Very low-noise electrical samplers (280 µV at 20 Ghz, 450 µV at 60 Ghz, typical)
- Selectable bandwidths (module 80e07, 08, 09, 10) allow the user to trade-off sampler bandwidth and noise for optimal data acquisition performance

- Remote samplers (module 80e07, 08, 09, 10) or compact sampling extender module cables support minimal signal degradation by allowing the sampler to be located in close proximity to the device under test
- World's highest-performance integrated TDR (10 ps typical step rise time) supports exceptional impedance discontinuity characterization and high dynamic range for S-parameter measurements to 50 Ghz

Analysis

- Standard Analysis Capabilities:
 - Complete suite of over 120 automated measurements for NRZ, RZ, and Pulse signal types
 - Automated mask testing with over 80 industry-standard masks. New masks can be imported into the DSA8300 to support new emerging standards. In addition, users can define their own masks for automated mask testing
- Vertical and Horizontal histograms for statistical analysis of acquired waveforms
- Vertical, Horizontal, and Waveform cursors (with measurements)
- Jitter, Noise, BER, and Serial Data Link Analysis is provided through the 80SJNB Basic and Advanced software application options
- Advanced TDR Analysis, S-parameter measurements, Simulation Model Extraction, and Serial Link Simulation capabilities are provided through the IConnect® Software application options

High Test Throughput

- High Sample Acquisition Rate up to 200 kS/s per channel
- Efficient Programmatic Interface (IEEE-488, Ethernet, or local processor access) enable High Test Throughput

Install Your Instrument

Unpack the instrument and check that you received all items listed as Standard Accessories. Recommended accessories and probes, instrument options, and upgrades are listed in the online help. Check the Tektronix Web site (www.tektronix.com) for the most current information.

Standard Accessories

Accessory	Tektronix part number
DSA8300 Digital Serial Analyzer Quick Start User Manual	071-2897-XX
Certificate of Traceable Calibration for product at initial shipment	Not orderable
Business reply card	Not orderable
Microsoft Windows compatible keyboard	119-B146-00
Microsoft Windows compatible mouse	119-6936-00
Instrument front cover	200-4519-00
Accessory pouch	016-1441-00
Touch screen styluses (2)	119-6107-00
ESD wrist strap with 6 foot coiled cord	006-3415-04
DSA8300 Product Documentation Kit (CD)	020-3082-XX
DSA8300 Online Help (part of application software)	Not orderable
DSA8300 Programmer Online Manual (part of application software)	Not orderable
DSA8300 Product Software Install Kit	020-3088-XX
DSA8300 Operating System Restore Kit	020-3089-XX
Power cord	Type dependent on selection during order placement

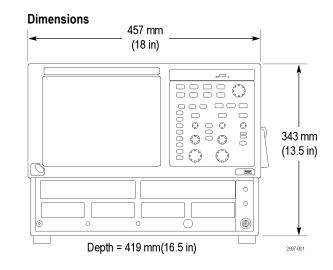
Operating Considerations

The following information lists the specifications related to the operation of the mainframe. Refer to the DSA8300 Digital Serial Analyzer Specifications and Performance Verification Manual for a complete list of specifications.

Mechanical

Clearance requirements

- Top, Front, and Rear: 0 mm (0 in)
- Sides: 51 mm (2 in)
- Bottom: 19 mm (0.75 in)



Weight	19.5 kg (43.0 lb.). This does not include any accessories or modules.
Orientation	Place the instrument on a cart or bench. The instrument should rest on its bottom or rear feet. The front feet fold down to angle the instrument.
Rack mounting	An optional rack mounting kit (Option 1R) is available.
Environmental	
Temperature	10 °C to +40 °C
Relative humidity	20% to 80%, with a maximum wet bulb temperature of 29 °C at or below +40 °C
Altitude	3,000 m (9,843 ft.)

Power Supply

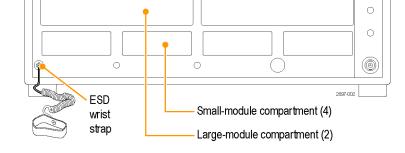
Source voltage and Frequency	100 - 240 V_{RMS} ±10%, 50 - 60 Hz or 115 V_{RMS} ±10%, 400 Hz
Power Consumption	600 watts maximum Typically, 240 watts (fully loaded); 160 watts (mainframe with no modules)
Input Connectors	

Trigger Direct Input range	±1.5 V (DC + peak AC) maximum input voltage
Trigger Prescaled Input absolute maximum input (typical)	±1.1 V _{P-P}
External 10 MHz Reference Input	500 mV_{p-p} to 5 V_{p-p} AC coupled into 1 k\Omega, ±5 V maximum

Installing Modules

CAUTION. To prevent damage to modules, do not transport or ship the instrument with modules installed. Modules are also sensitive to electrostatic discharge (ESD). To avoid ESD damage, always use an ESD wrist strap when installing or removing modules and when connecting signals to the module inputs. Never install or remove modules while the instrument is powered on.

- 1. Always use an ESD wrist strap (provided) when installing and removing modules.
- You can install up to two large sampling modules and four small modules for a total of 8 inputs.



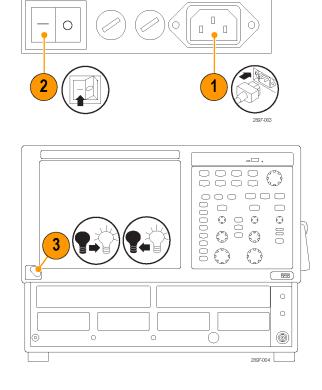
Following are some typical module installations illustrating the interaction between large compartment channels and small compartment channels.

NOTE. A large compartment module that only derives power from the compartment does not use any small compartment input channels.

Eight channels: No large and four small modules	CH1 Module not installed		CH3 Module not installed		
	CH 1 CH 2	CH 3 CH 4	CH 5 CH 6	6 CH 7 CH 8	
Six channels: Two large modules and two small modules	CH1 module installed		CH3 module installed		
	CH 1 CH 2 N.A. N.A.	CH 3 CH 4 N.A. N.A.	CH 5 CH	6 CH 7 CH 8	
Seven channels: One large module, installed in CH3 compartment, and three small modules	CH1 module	not installed	CH3 module installed		
modules	CH 1 CH 2	CH 3 CH 4 N.A. N.A.	CH 5 CH	6 CH 7 CH 8	
Seven channels: One large module, installed in CH1 compartment, and three small modules	CH1 modu	ile installed	CH3 mod	ule not installed	
modulos	CH 1 CH 2 N.A. N.A.	CH 3 CH 4	CH 5 CH	6 CH 7 CH 8	

Powering the Instrument On and Off

- 1. Insert AC power cord.
- 2. Toggle the mains switch to on.
- **3.** Use the front panel power button to switch the instrument on and off.

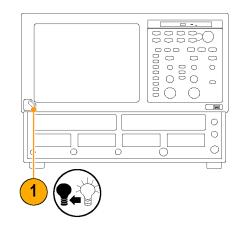


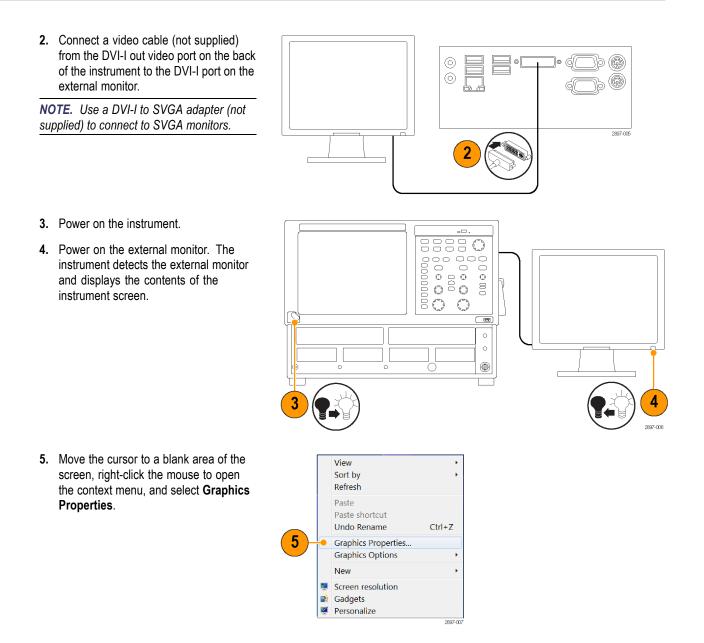
CAUTION. To prevent damaging the modules, do not install or remove any modules while the instrument is powered on.

Adding a Second Monitor

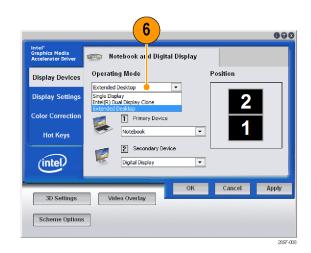
You can add a second monitor to provide two screens for viewing instrument applications or readouts.

1. Power off the instrument.

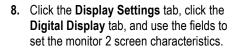




6. Select the display mode from the **Operating Mode** list.

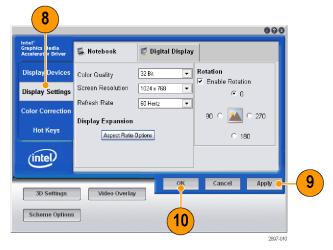


 If using an extended desktop, click the external monitor 2 box in the **Position** pane and drag the monitor to the position that relates to the physical position of monitor 2 in relation to monitor 1.



- Click Apply. The instrument makes the selected changes and then prompts you to keep the changes (if OK) or to Cancel the settings and return to the previous settings. If the new settings are correct, click OK. You have about 15 seconds before the instrument automatically returns to the previous display settings.
- **10.** Click **OK** to close the Intel Graphics Media Accelerator Driver window.

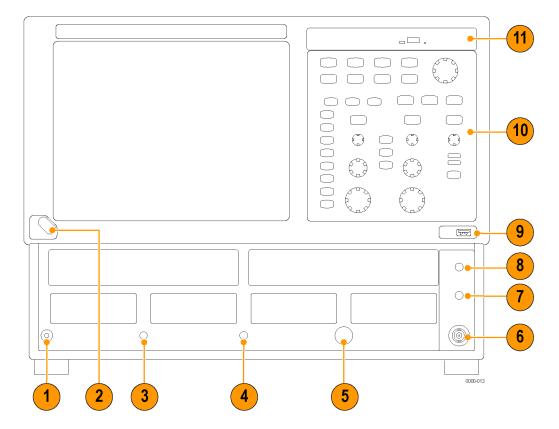




Getting Acquainted with Your Instrument

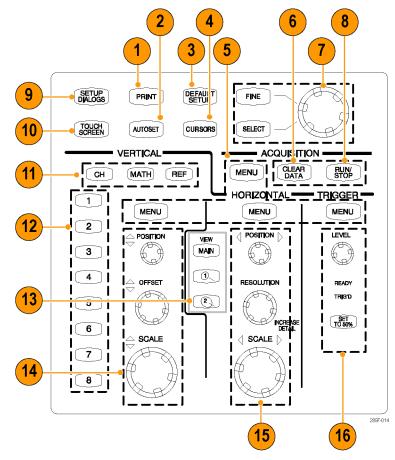
Front Panel

The front panel of your instrument gives you access to the module compartments and the control panel.



- **1.** Antistatic connection terminal (1 $M\Omega$).
- 2. On/Off switch.
- 3. Clock Input/Prescale Trigger input.
- 4. Trigger direct input.
- 5. Trigger probe power.
- 6. External 10 MHz reference input.
- 7. DC calibration output.
- 8. TDR Clock Out signal.
- 9. USB port.
- 10. Control panel.
- 11. DVD/CDRW drive.

Control Panel

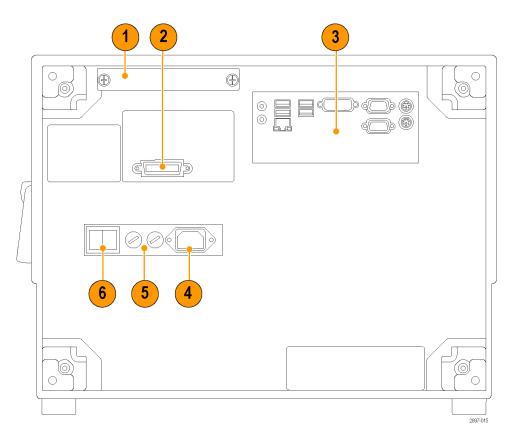


- 1. Access print dialog box for printing the display.
- 2. Optimize instrument settings for the selected channel to automatically display a waveform.
- 3. Quickly return the instrument to default control settings.
- 4. Display measurement cursors and assigns the knob and SELECT buttons to control them.
- 5. Menu buttons quickly access the setup dialog box for more detailed setup.
- 6. Clear all data and measurement results.
- 7. Adjust most control fields in setup dialogs. Push the SELECT button to select the active cursor (when cursors are enabled). Push the FINE button to toggle between normal and fine adjustment.
- 8. Start and stop acquisition.
- 9. Display the Setup dialog box for comprehensive setup of the instrument.
- 10. Toggle the touch screen on and off. Use the touch screen to control UI when you have not installed a mouse.
- 11. Select a waveform type (Channel, Reference, or Math) to display or adjust on screen (selected button lights).
- 12. Push a channel button to select and display a waveform for that channel. A lit button indicates selected and displayed waveforms for that channel. An unlit button indicates that the channel is not selected.

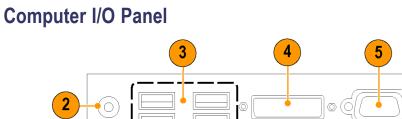
- **13.** Select among displayed timebase views or display and select a magnified timebase view. Push the selected view to turn it off (except main, which is always on).
- 14. Vertically scale, position, and offset selected waveform.
- 15. Horizontally scale, position, and set record length of selected waveform.
- 16. Set trigger level (applies only to Trigger Direct Input) and use lights to monitor trigger state.

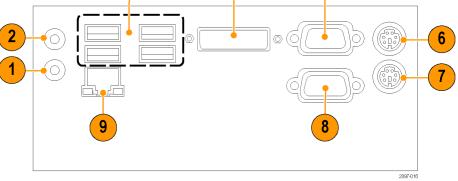
Rear Panel

The rear panel of your instrument allows you access to input and output connectors and the AC input.



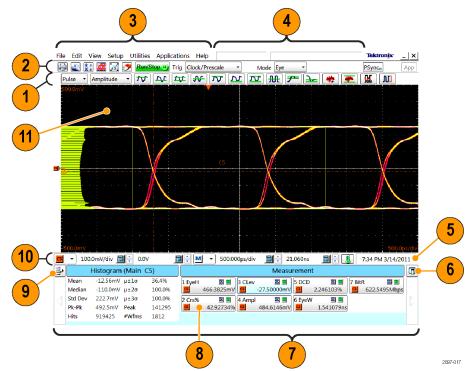
- 1. Removable hard drive.
- GPIB port. The instrument is factory set to be a talk/listen device, allowing you to control the instrument via the GPIB
 port. You can change the instrument to be a GPIB controller, allowing you to control other devices via the GPIB port, or
 set the instrument to be off bus. Refer to the Programmer Manual installed on the instrument.
- 3. Computer I/O panel. (See page 13, Computer I/O Panel.)
- 4. AC input.
- 5. Fuses.
- 6. Mains power switch.



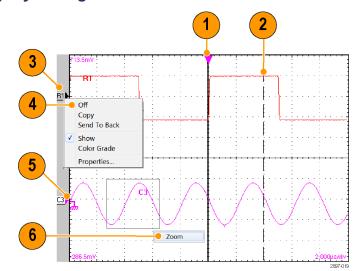


1 . /	Audio line out	2.	Mic input	3.	USB ports
4. [DVI-I video out for dual-monitor display	5.	COM1	6.	PS2 (keyboard)
7. F	PS2 (mouse)	8.	COM2	9.	LAN

The User Interface



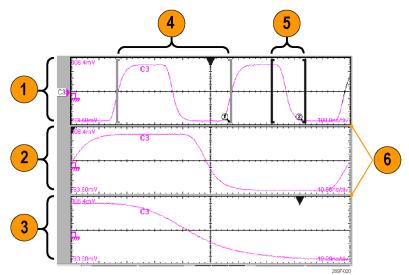
- 1. Measurements Bar. Access to automated measurements by signal type and category; click measurement buttons to measure the selected waveform.
- 2. Tool Bar. Access to key features including printing, setup dialogs, math waveform setup, waveform database, autoset, clear data, acquisition mode, triggering, and applications.
- 3. Menu Bar. Access to data I/O, printing online help system, and setup functions.
- 4. Status Bar. Waveform count and trigger/acquisition status.
- 5. System Time/Date and compensation status.
- 6. Readout Docking. Select to undock the readout area from the application.
- 7. Readout area. Displays waveform and measurement details. Use the arrow buttons at each end to scroll the contents.
- 8. Readout. Right click on a readout to display a context menu for additional settings for that readout category.
- 9. Readout Enable. Toggles the readout type (cursor, histogram, mask, measurement, and waveform) on or off.
- **10.** Controls Bar. Click to select a waveform (channel, math, or reference), as well as quick access to scale, offset, and position controls for adjustment.
- 11. Display. Contains live, reference, and math waveforms, and histograms, cursors and test masks when enabled.



Display - Single Waveform View

- 1. Drag the Horizontal Reference to move the point around which the horizontal scaling expands and contracts the waveforms.
- 2. Drag cursors to measure waveforms on screen.
- 3. Drag the waveform icon vertically to position waveform.
- 4. Right-click on a waveform or its icon to open the context menu with setup controls and properties.
- 5. Drag ground reference icon to add offset to a waveform.
- 6. Drag across the waveform area to horizontally zoom the boxed waveform segment to full screen width.

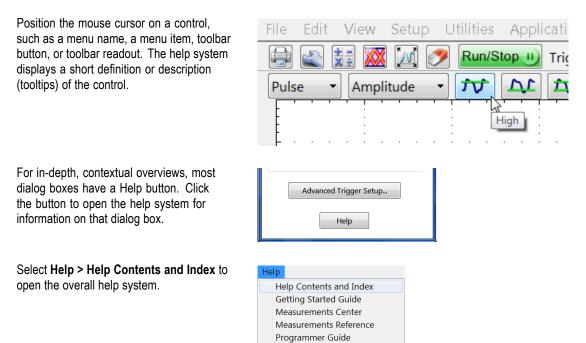




- 1. MAIN View.
- 2. Mag1 View.
- 3. Mag2 View.
- 4. Drag the markers to enclose the portion of waveform to appear in Mag1 View.
- 5. Drag the markers to enclose the portion of waveform to appear in Mag2 View.
- 6. Drag the border between graticules to vertically size Main, Mag1, and Mag2 Views.

Accessing Online Help

In-depth information about all the features of your instrument is available in the online help.



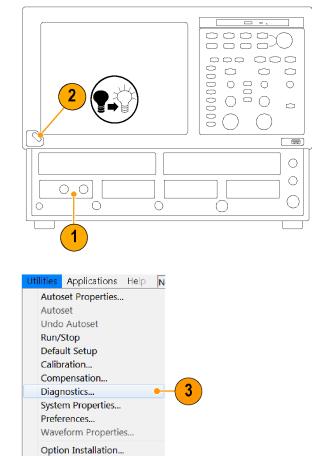
About DSA8300

Inspect Your Instrument

Use the following procedure to verify the functionality of your instrument. For a complete performance verification, see the DSA8300 Digital Serial Analyzer Performance Verification and Specifications Manual, which can be downloaded from the Tektronix Web site.

Verify Internal Diagnostics Pass

- 1. Install all modules to be diagnosed.
- 2. Power on the instrument and wait 20 minutes for the warm-up period.



3. Select Utilities > Diagnostics.

2897-021

- 4. Select the Subsystem Level tab.
- Select all the entries by clicking the first entry Control Proc and dragging down to select the rest. All entries should be highlighted.
- 6. Verify that the Loop and Halt on Failure boxes are unchecked.
- 7. Click Run.
- 8. Verify that all tests display **Pass** in the Status column when the diagnostics complete. If diagnostic failures occur, contact your local Tektronix service center.

osystem Level Area Level	st Level		
Subsystems	Result	Failures	
Control Proc	Pass	0	
Acq 1A (Ch1 small)	Pass		Run
Acq 1B (Ch2 small)	Pass		
Acq 2A (Ch1 large)	Pass		🖾 Loop
Acq 2B (Ch2 large)	Pass		
Acq 3A (Ch3 small)	Pass		Halt on failure
Acq 3B (Ch4 small)	Pass		
Acq 4A (ChA TB)	Pass		
Acq 4B (ChB TB)	Pass		1
Acq 5A (Ch5)	Pass		Loop count: 1
Acq 5B (Ch6)	Pass		
Acq 6A (Ch3 large)	Pass		
Acq 6B (Ch4 large)	Pass		Abort
Acq 7A (Ch7)	Pass		
Acq 7B (Ch8)	Pass	0	
ubsystem: Acq 78 (Ch8)	\mathbf{x}		
rea: Vertical	8		
est: Ground Ref	U		

Optimizing Measurement Accuracy

The instrument provides several utilities that optimize measurement accuracy:

- Signal path compensation (SPC) configures signal paths to improve measurement accuracy at the current ambient temperature.
- Dark-level compensation maximizes the accuracy of extinction ratio and other optical measurements
- User Wavelength Gain compensation optimizes an optical channel for a custom input signal

Signal Path Compensation

Signal path compensation (SPC) configures the instrument and module signal paths to make accurate measurements at the current ambient temperature.

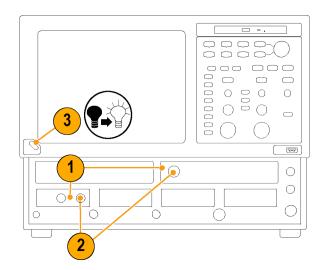
You should run a SPC:

- After adding a module to the instrument
- After adding or removing an extender cable from a module.
- After moving a module to another slot.
- The ambient temperature has changed more than 5 °C since the last signal path compensation.
- When making measurements at vertical scale settings less than or equal to 5 mV/div. Perform the signal path compensation once a week under these conditions. Failure to do so may result in the instrument not meeting warranted performance levels at these volts/div settings.

NOTE. You must save the compensation results or they will be lost when the instrument is powered down.

After installing a module or moving a module to another compartment, you must power on the instrument and allow the temperature (of the instrument and module(s)) to reach a stable equilibrium (normally 20 minutes).

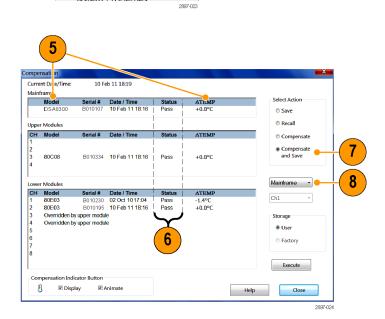
- 1. Install all modules to be compensated.
- Install all terminations and dust covers. Failure to install the 50 Ω terminations on electrical inputs can cause erroneous compensation failures or results.
- Power on the instrument and wait 20 minutes for the warm-up period.



4. Select Utilities > Compensation

- 5. Verify that the main instrument (mainframe) and all installed modules are listed. The temperature change from the last compensation is also listed.
- Check that the Status for all items to compensate changes from Warm Up to Pass, Fail, or Comp Req'd.
- 7. Select Compensate and Save (default).
- **8.** Select the item on which to run compensation:
- Mainframe (default selection) to compensate just the main instrument
- All modules to compensate all installed module channels
- Module to compensate specified channels of the selected module
- 9. Click Execute.

Follow the on-screen instructions regarding signal and trigger inputs and terminations; be sure to follow electrostatic handling precautions (see the user information for your sampling module) when following these instructions.

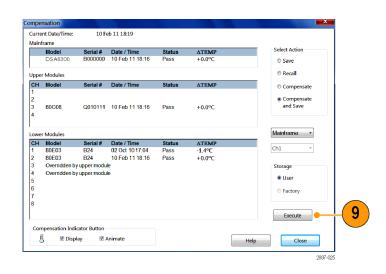


4

Setup Utilities Applications Help Autoset Properties...

> Compensation... Diagnostics... System Properties

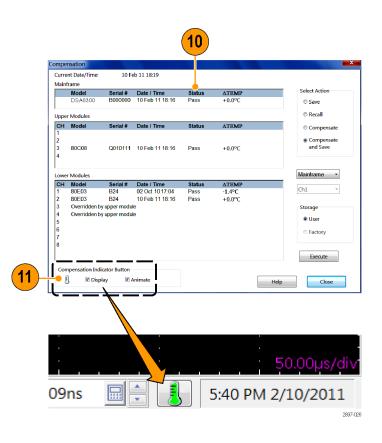
Autoset Undo Autoset Run/Stop Default Setup Calibration...



10. Verify that the compensation routines pass.

If the status is **Fail**, run the compensation again. If **Fail** status continues, the module or main instrument may need service.

 Use the Compensation Indicator Button to display or hide the compensation indicator on the main display. Green means that all modules have been successfully compensated. Yellow means that the instrument has not competed its 20 minute warm-up period. Red means that one or more modules require compensation.



Dark-Level and User Wavelength Gain Compensations

NOTE. You should run the Signal Path Compensation procedure before running dark-level or user wavelength gain compensation. (See page 20, Signal Path Compensation.)

These procedures apply only to optical modules.

Dark-level compensation maximizes the accuracy of the extinction ratio and other optical automatic measurements. Dark-level compensation performs a subset of the module compensation process. It is designed to be fast so it can be performed frequently, just before measurements are taken. Dark-level compensation is not saved and is only valid for the selected bandwidth or filter path and the internal optical power meter.

User Wavelength Gain compensation optimizes an optical channel for your custom input signal.

1. Install one or two optical sampling ____ modules in the instrument. Set the \bigcirc acquisition system to run continuously. - **-**0 0 0 ۲ 2897-027 2. Select the channel to compensate. VERTICAL CH) (MATH) REF (1)2 MENU 2 3. Select Setup > Vertical. Utilities Applicatic Setup 3 Vertical Horizontal Acquire 2897-028

To run the Dark-Level compensation:

 In Vert Setup dialog box, click the Dark Level button under Compensation. Follow the instructions on screen.

NOTE. You need to switch from the Basic dialog to the Optical dialog to access the Dark Level Calibration button.

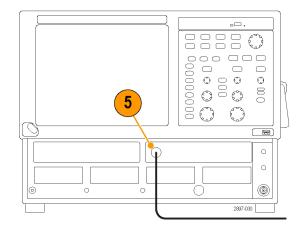
Repeat steps 2 and 4 for any additional optical channels you want to compensate.

To run the User Wavelength Gain compensation (for signals at wavelengths other than the factory calibrated values; typically 850, 1310 and/or 1550 nm):

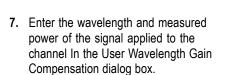
5. Use an independently-calibrated average optical power meter to measure the power of an optical signal source.

Then connect the signal to the optical module using the same fiber cable.





6. Click the User Wavelength Gain button in the Vert Setup dialog box.



8. Click OK to execute the compensation.



Cancel

ΟK

Compensate

8

Acquisition

This section contains concepts of and procedures for using the acquisition system. Detailed information is available in the online help.

Setting Up Signal Input

Use front-panel buttons to set up your instrument to acquire the signal.



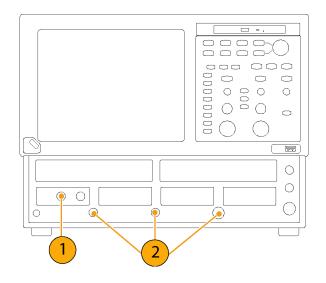
CAUTION. Sampling modules are inherently vulnerable to static damage. Always observe static-safe procedures and cautions as outlined in your sampling-module user manual.

 Connect the instrument to the device or signal under test using proper probing or connecting techniques. See the user manual for the installed sampling module for connection requirements.



CAUTION. Discharge electrical cables to ground before connecting them to a module.

2. Connect an appropriate trigger signal to the instrument. (See page 35, *Triggers*.)



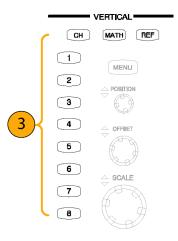
 Push the CH button (turns amber) to assign the waveform buttons (1 – 8) to operate on channel waveforms. Then select the proper waveform button.

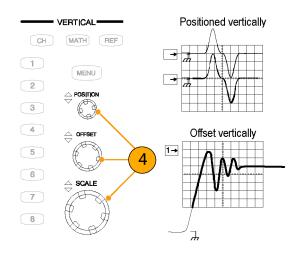
A waveform button lights when its channel is on; when on but not selected, the button is green; when on *and* selected, the button is amber.

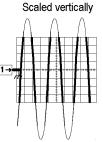
Push the **MATH** button to assign the waveform buttons to math waveforms. If the selected math waveform is not defined, the instrument opens the Define Math dialog box.

Push the **REF** button to assign the waveform buttons to reference waveforms. If no reference waveforms are loaded into the channels, the Recall Waveform dialog box appears.

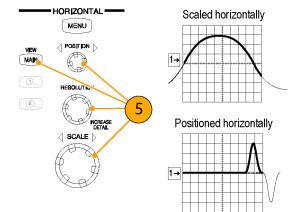
 Use the Vertical Position, Offset, and Scale knobs to adjust the vertical parameters of the selected waveform.







 Push the View Main button to make sure that the main time base view is selected. Use the horizontal Position, Resolution, and Scale knobs to scale and position the waveform on the screen and to set the sample resolution.



Quick Tips

- Vou can click a waveform trace or its reference indicator with the mouse pointer (or touch screen) to select it.
- Push AUTOSET to quickly set up instrument parameters and display a waveform based on the input signal.

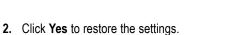
SETUP

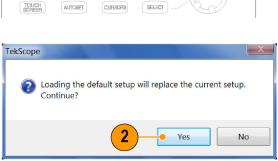
Push Set to 50% in the Trigger controls, if required, to stabilize the display when using the Trigger Direct Input connector.

PRINT

Using Factory Default Setup

1. To quickly return to the factory default settings, push **DEFAULT SETUP**.





FINE

1

DEFAULT

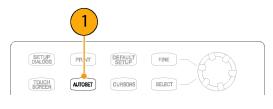
Using Autoset

Use Autoset to automatically set the instrument vertical, horizontal, and trigger parameters and display a waveform based on the characteristics of the input signal.

NOTE. Make sure that the input channel(s) for the signal are on and selected before doing an autoset.

1. Push the AUTOSET button to execute an Autoset.

If you use Autoset when one or more channels are displayed, the instrument uses the selected channel for horizontal scaling. Vertically, all channels in use are individually scaled.

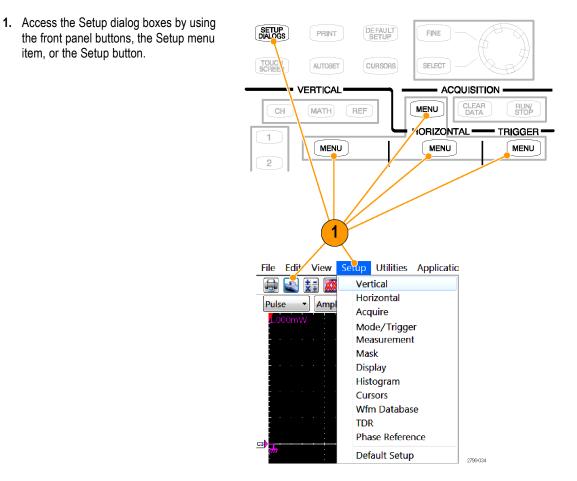


Quick Tip

- If the instrument does not autoset to your signal, select Setup > Horizontal, click the Comm Standard button, and select the signal type. Then push the Autoset button again.
- Select Utilities > Define Autoset to change the Autoset properties.

Accessing the Setup Dialog Boxes

The Setup dialog boxes are the key controls for setting instrument parameters such as Mode/Trigger, horizontal, vertical, acquisition, cursors, histogram, display, and mask.



2. Click on the tabs to select among the setup dialog boxes.

	Setups					X
2	Wfm Datab	ase	Hist Cursor			Meas
	Phase Ref	Mask			TDR	Disp
	Vert	Ho	Horz		Acq	Mode/Trig
Ľ			· — —			

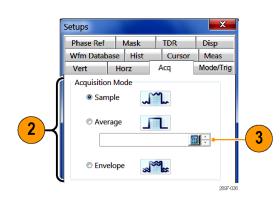
Changing the Acquisition Mode

Use the procedure that follows to set the data-acquisition mode and specify acquisition start and stop methods.

1. Push the Acquisition **MENU** button to display the Acq Setup dialog box.

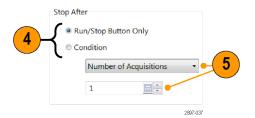


- 2. Select the acquisition mode.
- 3. For Average mode, enter the number of samples to average.



- Set the Stop After mode and action by selecting Run/Stop Button Only or Condition.
- 5. If you selected Condition, choose a condition on which to stop from the drop-down list. If the condition requires a count, enter a count.
- 6. Enter a filename if you selected Print to File or Save all Waveforms.
- Select Ring Bell if you want the instrument to produce an audio tone when the acquisition stops.

NOTE. You must connect an external speaker to the instrument to hear a tone on a stop condition.





- 8. Push **RUN/STOP** to start the acquisition.
- 9. Push **RUN/STOP** again to stop the acquisition.



Quick Tips

- Run/Stop is available on both the front panel and the touch screen.
- If Stop After is set to Condition, pressing RUN/STOP causes only one acquisition to run if the original condition has been met. You need to push CLEAR DATA so that the condition must be met again.

Waveform Databases

NOTE. Certain measurements require the use of a waveform database. The instrument automatically sets the measurement system to use a waveform database if one is available.

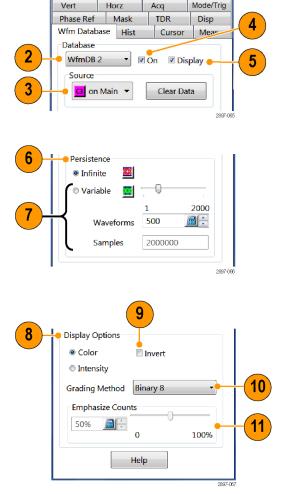
The four available waveform databases can be used for measurements, histogram calculations, mask testing, and generating a density-style, graded display. Waveform databases may be automatically allocated for measurements, histograms, and mask testing.

Setups

- Select Setup > Wfm Database from the main menu.
- 2. From the pulldown menu under Database, select one of the four available databases.
- 3. Click the **Source** button to select the waveform source.
- 4. Click **On** to start accumulating data from the selected source.
- 5. Click **Display** to turn on the display of the waveform database.
- **6.** Select the Persistence mode for the selected waveform.
- 7. If you selected Variable persistence, you can specify the number of waveforms that are included in the waveform database.

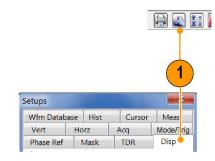
The following Display Options affect all waveform databases that you display:

- 8. Click a grading display option.
- **9.** Click **Invert** to emphasize the least occurring pixels by reversing the intensity/color assignments to each grading partition.
- 10. Select one of the four grading methods.
- **11.** If you selected one of the two Emphasized grading methods, slide the Emphasize Counts percentage control to specify the range of counts you want emphasized.



Setting the Display Style

1. Click the Setup button and click the **Disp** tab.



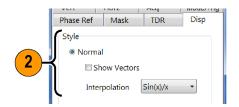
2. Select a waveform display style.

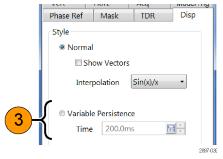
Normal selects a display with no acquisition data persistence. Waveforms are displayed with the new data from ongoing acquisitions replacing data acquired from previous acquisitions.

Show Vectors turns on display lines between waveform dots; deselect to display only dots.

- Sin(x)/x interpolation computes record points using a curve fit between the acquired samples.
- Linear interpolation computes record points between actual acquired samples by using a straight line fit.
- 3. Variable Persistence makes data persist for a specified time. New waveform displays accumulate data as new waveform records acquire, but with continuous replacement of the oldest data.

Set a time at which the oldest data is removed.





Infinite Persistence makes data persist until you change some control or explicitly clear the data. Waveform displays accumulate data as the instrument acquires new data, resulting in a buildup of data in all time slots.

4. Use the Graticule settings to select the graticule style and the graticule color and screen background.

© Infinit	e Persistence	
4	Graticule	
	Style	Full
	Background	•
	Foreground	•
		2897-040

Triggers

This section contains concepts and procedures for using the trigger system. Detailed information is available in the online help.

Triggering Concepts

Trigger Event

A trigger event occurs when the trigger source (the signal that the trigger circuit monitors) passes through a specified voltage level in a specified direction (the trigger slope). The trigger event sets the time-zero point in the waveform record and all sampled waveforms on all inputs are measured with respect to that event.

When a trigger event occurs, the instrument acquires one sample of all active (selected) signals. When the next trigger event occurs, the instrument acquires the next sample. This process continues until the entire record is filled with acquired samples. Without a trigger, the instrument does not acquire any samples. Sampling oscilloscope behavior differs from that of real-time acquisition systems, which can acquire a complete waveform record from a single trigger event.

Trigger Sources

The trigger source sets the source that the trigger system monitors for a trigger event. The source can be:

- A clock signal used for acquiring optical or electrical serial data streams. The source of the clock can be internal or external to the instrument:
 - External Clock Input/Prescale Trigger. Connect the trigger signal to the front panel connector. Triggering is guaranteed for clocks from 150 Mb/s up to 15 Gb/s (and will typically work up to 20 Gb/s).
 - Internal Clock-recovery trigger. This trigger source can be an optical sampling module that is equipped with a clock-recovery option, or a dedicated electrical clock recovery module. Available clock recovery triggering rates depend on the sampling module. For example, the 80C08C Optical Sampling Module with option CR4 provides internal clock-recovered triggers for any data rate (standard or custom) from 8.5 Gb/s to 12.5 Gb/s.
- The instrument TDR clock, with selectable TDR Step repetition rates. The TDR CLOCK OUT connector on the instrument front panel supplies a replica of the TDR clock,
- A low-repetition rate signal (DC to 3 GHz) connected to the External Trigger Direct input. While this trigger source can be used to acquire serial data signals at rates up to 3 Gb/s, its primary use is for low repetition rate (<150 MHz) signals or for signals where you need additional conditioning of the input trigger signal (such as trigger level, slope, and so on). This flexibility comes at the cost of increased instrumentation jitter.</p>
- An internal clock for Free Run acquisition of signals. (Since the acquired signals are not synchronous with the trigger, this trigger source is useful primarily for locating a signal or clock and applying the appropriate offset to the data or trigger for proper synchronous waveform acquisition.)

Trigger Modes

When a Clock source is selected (whether Internal Clock recovery or external Clock Input/Prescale Trigger input) as the trigger source, you must select the Trigger Mode. Available trigger modes are Eye, Pattern, and Other:

- Select Eye mode if the signal you are acquiring is synchronous with the selected clock source and you want to display the acquired data as an "eye diagram" overlaying all of the acquired data bits with minimal clock to data jitter.
- Select Pattern mode if the signal you are acquiring is synchronous with the selected clock source and you want to display the individual bits as a "bit stream", with minimal clock to data jitter.

NOTE. This mode is only available if the ADVTRIG option is present on the instrument.

Select Other mode if the signal you are acquiring is synchronous with the selected clock source and you want to display the acquired data showing the effects of any clock modulation (such as Spread Spectrum Clocking).

Application	Waveform display	Trigger Source/Mode
Optical or Electrical Serial Data (NRZ) Mask and Parametric Testing (minimum jitter)	\times	 Trigger Source: Clock Input/Prescale Trigger input or Internal Clock Recovery Clock Trigger Mode: Eye
Optical or Electrical Serial Data Pattern Analysis (including		 Trigger Source: Clock Input/Prescale Trigger input or Internal Clock Recovery Clock Trigger Mode: Pattern (this mode of operation requires the Advanced Trigger Option ADVTRIG).
JNB analysis)		Maximum supported pattern length= 2^{23} .
Optical or Electrical Serial		 Trigger Source: Clock Input/Prescale Trigger input or Internal Clock Recovery
Data (NRZ) Mask and Parametric Testing (w/ clock modulation effects – SSC)		Clock Trigger Mode: Other
Clock Signal Analysis		 Trigger Source: Clock Input/Prescale Trigger input or Internal Clock Recovery
		Clock Trigger Mode: Eye

Table 1: Application-based trigger modes

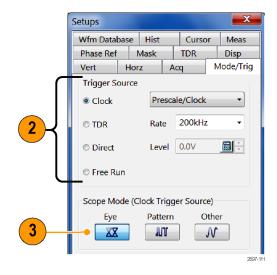
Application	Waveform display	Trigger Source/Mode
TDR/TDT and S-Parameter Analysis		Trigger Source: TDR
Low Repetition Rate Signals		Trigger Source: External Direct Trigger input

Table 1: Application-based trigger modes (cont.)

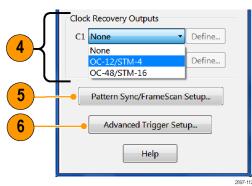
Setting Trigger Controls

Nearly all trigger parameters are set in the Mode/Trig Setup dialog box.

- 1. Push the Trigger **MENU** button to display the **Mode/Trig** Setup dialog box.
- 2. Select a trigger source.
- If the trigger source is Clock, select the Scope Mode.



- Use the Clock Recovery Outputs fields to select a measurement standard and define clock recovery parameters on applicable modules.
- 5. Click Pattern Sync/FrameScan Setup to set pattern sync, autosync and FrameScan parameters. (See page 39, Setting Pattern Sync and FrameScan Controls.)
- 6. Click Advanced Trigger Setup to set trigger level, slope, holdoff, and other trigger parameters.



Quick Tips

- Selecting Clock > Prescale/Clock as the trigger source requires that an appropriate trigger signal be connected to the CLOCK INPUT/PRESCALE TRIGGER input connector.
- If you select the Clock trigger source, you also need to select the Scope Mode (Eye, Pattern, or Other).
- Pattern (Scope Mode) triggering is only available if the Advanced Trigger option ADVTRIG is installed on the instrument.
- If you select Pattern (Scope Mode), use the Pattern/Sync/FrameScan Setup dialog to specify the pattern characteristics.
- Selecting a Clock Recovery trigger source requires that a module with clock recovery is available. Select the clock recovery standard from the pulldown lists or user-specified range controls.
- Selecting TDR as the trigger source uses the clock frequency setting in the Rate control.

- Selecting Direct as the trigger source requires an appropriate trigger signal be connected to the DIRECT INPUT connector.
- The Level control applies only when the trigger source is set to Direct.

Setting Pattern Sync and FrameScan Controls

NOTE. The pattern sync controls are only available if the instrument has the ADVTRIG option installed and the instrument is set up for Pattern Trigger mode.

- 1. Select Setup > Mode/Trigger. 2 Pattern Sync/FrameScan Setup. 2. Click Pattern Sync/FrameScan Setup. Advanced Trigger Setup.. Help 3. Select the parameters for pattern Pattern Sync/FrameScan Setup synchronization: Pattern Sync Control AutoSync Options Select the Data Rate (bit rate) (default Data Rate 🖃 🗧 List... 🗹 Data Rate Pattern is 2.48832 Gb/s). List... Pattern Length Length 3 Data:Clock ÷ Edit... ☑ Data:Clock Ratio Select the Pattern Length (default is Ratio 127). AutoSync to Selected Waveform Main Position BTZ Select a Data:Clock Ratio FrameScan Scan Bits (data-to-clock ratio) (default is Enabled 64 Clock Source 1:1). Clock/Prescale Reset Set the Main timebase delay position. Close Help This is the same control as found in the Setup > Horizontal tab.
- 4. Use the AutoSync feature to automatically detect the data rate, pattern length and/or data-to-clock ratio of the applied data and clock signals (data to a sampling module channel and the clock to the Clock/Prescale Trigger input, or from an internal clock recovery source).
- Enable FrameScan to automatically scan through a pattern (or part of a pattern).
 This FrameScan control is the same as the FrameScan control in the Horizontal Setup dialog box (changing either one affects the other).

Pattern Sync/FrameScan Setup		
Pattern Sync Control	-AutoSync Options	
Data Rate	🗹 Data Rate	1
Pattern Length List	☑ Pattern Length	4
Data:Clock Edit	Data:Clock Ratio	
Position BTZ	AutoSync to Selected Waveform	
Set as New Reference	FrameScan Scan Bits	
Clock Source Prescale/Clock •	Enabled 64	5
Close	Help	
	2897-043	

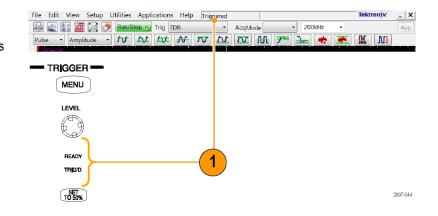
Quick Tips

- All pattern sync controls are disabled (grayed out) if the Advanced Trigger option (ADVTRIG) is not enabled in the instrument or the trigger source mode is not Pattern.
- The Data Rate in the Pattern Sync dialog box is tied to the Bit Rate control in the Horizontal setup dialog box. Changing either one affects the other.
- If the entered Data Rate does not match the rate of the selected communication standard in the Horizontal Setup, then the communication standard is changed to User.
- For highest reliability and speed, manually enter as many control values as possible. Uncheck the control value in the AutoSync Options area to enable manual entry.

Checking Trigger Status

You can check the status of the trigger from the front panel and in the application status bar. The status bar also displays the waveform count.

1. Check the READY and TRIG'D front-panel controls to determine the trigger status, or look at the trigger status in the application.



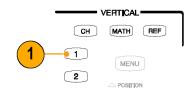
Waveform Measurements

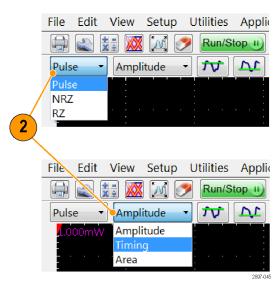
Your instrument features automatic measurements (with statistics), cursors, histograms, and waveform math processing to assist you in analyzing waveforms. This section contains concepts and procedures for analyzing waveforms. See the online help for more information.

Taking Automatic Measurements

Automated measurements are divided into waveform types (Pulse, NRZ (Non-Return-to-Zero), and RZ (Return-to-Zero)) and measurement categories (amplitude, time, and area).

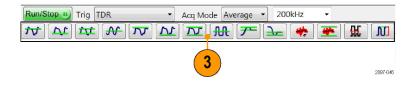
- Select the waveform to measure. You can measure a channel, reference, or math waveform.
- Select the waveform type and category from the buttons on the Measurement bar.





 Click on a measurement button in the Measurement tool bar. The instrument displays the most frequently used measurements for the selected waveform type and category.

You can also access all of the measurement types from the MEAS setup dialog box.



4. Read the results in the measurements Measurement readout. 1 Freq Λ 620.9921MHz B 2807.047 To see statistics: 5 5. Right click on any measurement readout to display its context menu. Measu rement Measurement 6 Λ. Λ 1 Rise 1 Rise 6. Select Show Statistics to display G 230.3446p G 229.1626ps Show Annotations measurement statistics in the Min 209.184ps Show Statistics measurement readout. Max 237.414ps Show Gates 228.394ps μ Setup... σ 2.94940ps 2897-048 To show measurement annotations: 7. Right click on any measurement readout Measurement to display its context menu. 2 Rise ~ 8. Select Show Annotations to display 8 215.6535 🗸 Show Annotations C3 annotations that indicate which portion of Show Statistics the waveform is being measured as well Show Gates as reference levels for the measurement. Setup... 2897-049 9. Note the portion of the waveform being 9 measured. 10. Note the reference levels for the measurement. 10

To measure a waveform database:

11. Select Setup > Meas from the application menu bar.

In the Meas Setup dialog box, make sure to select a measurement slot (one of **Meas 1** through **Meas 8**).

12. In the Source tab, check the Use Wfm Database option.

Setups TDR Mask Disp Phase Ref Horz Acq Vert Mode/Trig Wfm Database Hist Meas 11 Cursor • 🗹 On Meas 1 C3 Pk-Pk Noise Select Meas Value 5.00000000 µW Show Stats Clear Stats Source1 Source2 Set to Default Source Region HiLow RefLevel C3 on Main 🔺 12 🗵 Use Wfm Database Clear Signal Type Pulse NRZ RZ Λ x Δ Statistics Weighting 32 **□** + Annotations Help 2897-051 X Setups Acq Mode/Trig Vert Horz Phase Ref Mask TDR Disp 13 Wfm Database Hist Meas Cursor ſ On • Meas 1 C3 Rise Select Meas Value 214.297985846656 ps Show Stats Clear Stats Source1 Source2 Set to Default

To localize a measurement:

- 13. Select Meas.
- 14. Select the Region tab.
- **15.** Click the **On** box to turn gating on and to display the gates on screen.
- 16. Use the G1 (Gate1) and G2 spin controls to adjust the gates on screen such that the area to measure is between the gates.

14

15

Source Region

33.20%

65.80%

0 +/-

Edges

Direction

Gates G1

G2

HiLow

RefLevel

0 -

16

20.82ns

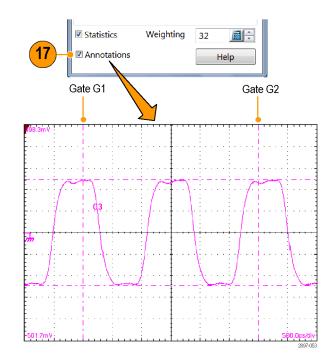
21.48ns

0 🔶

0 +



17. Click the **Annotations** box to display which portion of the waveform is being measured and the reference levels for that measurement.



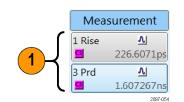
Quick Tips

- If, at the time you first create a measurement, the measurement source you select is displayed as a waveform database, the database will automatically be measured. Deselect the User Wfm Database option if you want to measure the vector waveform instead of the database.
- Gate values are entered as a percentage of the waveform, displayed from left to right. If no keyboard is installed, access the virtual keyboard and use the touch screen to enter values.
- You can select and drag the gates to new locations by using a mouse or the touch screen.

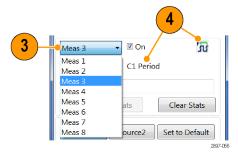
Turning Off Automatic Measurements

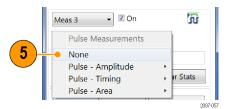
You can assign and display up to eight automatic measurements. If you need an additional automatic measurement, and all measurement slots are used, reassign a current measurement slot to the new measurement.

- Note the current measurement assignments. In this example, measurement slots 1 and 3 have measurements assigned and displayed.
- 2. Select Meas (measurement) from the Setup dialog box.
- **3.** Use the pulldown list to select **Meas 3** (measurement slot 3).
- Note that measurement slot 3 has a measurement assigned and is displayed (On).
- 5. Click Select Meas > None to disable measurements on slot 3.
- 6. Note that measurement slot 3 is now labeled Not Defined and no measurement icon is displayed.



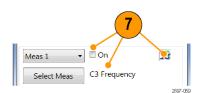








 Note that measurement slot 1 has a measurement assigned. It is set to not display, but the measurement slot is still used.



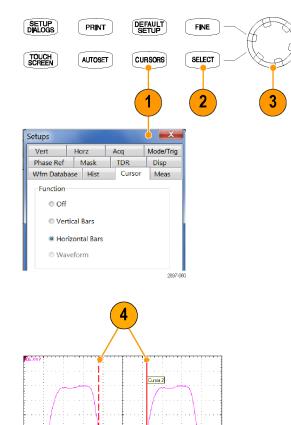
Quick Tip

To easily redefine a measurement slot, select Select Meas and choose a new measurement.

Cursor Measurements

Use cursors to measure amplitude and time quickly and with more accuracy than when visually using the graticule to take measurements. Because you position cursors wherever you want on the waveform, they are easier to localize to a waveform segment or feature than automatic measurements.

- 1. Push the CURSORS button:
 - Once for Vertical Bars
 - Twice for Horizontal Bars
 - Three times for waveform cursors
- Push the SELECT button to toggle selection between the two cursors. The active cursor is represented by a solid line.
- Turn the General Purpose knob to position each cursor on the waveform to measure the feature that interests you.
- 4. Vertical bars (V Bars) measure horizontal parameters (time, bits or distance).



5

▼ 5

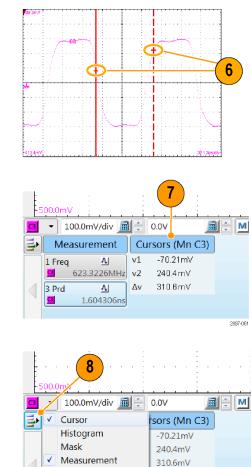
2897-06

Cursor 1

5. Horizontal bars (H Bars) measure amplitude parameters (volts, watts, ohms, rho).

- Waveform cursors measure vertical and horizontal parameters simultaneously. Waveform cursors are attached to the waveform and track with the waveform points.
- 7. Read cursor measurement results in the readouts area of the display.

8. Click this button to show or hide the cursor readouts.



Waveform

C3

Quick Tips

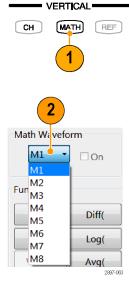
- Cursors require that at least one waveform is selected on the screen.
- Waveform cursors are not available if a waveform database is selected.
- You can drag a cursor to place it relative to the waveform.

- You can assign each cursor to a different waveform to measure differences between waveforms. Make these selections in the Cursor setup dialog box.
- If you use two magnified time base views, you can take precision timing measurements between two distant points on a waveform. Magnify each point of interest in a separate time base, and then place one cursor on each point. The Δ-time cursor readout will then reflect the position and resolution of the magnified time bases.

Math Waveforms

You create math waveforms by creating a math expression using the Define Math dialog box. In that dialog box, you apply numerical constants, math operators, and functions to sources (live or reference waveforms), measurement scalars (measurement readouts), or fixed scalars. You can display and manipulate these derived math waveforms much like you can the channel and reference waveforms.

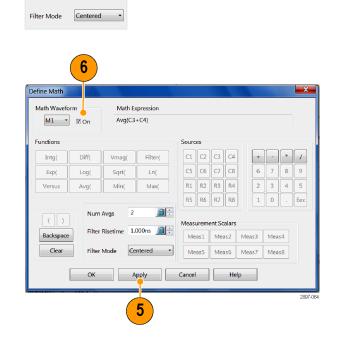
- Push the Vertical MATH button (once or twice if needed) to display the Define Math dialog box.
- Click the Math Waveform drop-down list in the dialog box and select one of the eight available math waveforms.



- Use the dialog box to define a math expression. Some guidelines for creating your expression follow:
 - Sources (C1 C8, R1 R8, and Meas 1 - Meas 8) should be set up before you use them (references and automated measurement scalars should be defined).
 - Elements that appear grayed out cannot be selected because they would result in an illegal entry.

Math Waveform Math Expression											
Functions				Sourc	es						
Intg(Diff(Vmag(Filter(C1	C2	C3	C4	+] -]	*	
Exp(Log(g(Sqrt(Ln(C5	C6	C7	C8	6	7	8	9
Versus	Avg(Min(Max(R1	R2	R3	R4	2	3	4	5
		R5	R6	R7	R8	1	0		Eex		
() Num Avgs 2 1 + Avgs Avgs Avgs Avgs Avgs Avgs Avgs Avgs						ent Sc Mea		Meas3	Mea	ıs4	
Clear Filter Mode		Mode Ce	entered 🔻	Me	Meas5 Me		eas6 Meas7		Meas8		

- **4.** Use the filter control in the dialog box to specify the rise time of any filters in the math waveform definition.
- 5. When you have defined the expression, click **Apply**.
- 6. Select the Math Waveform On box to display the waveform.



Quick Tip

If you select a waveform that is already defined, its math expression appears in the dialog box. To use the waveform, click the Clear button, which discards its previous math expression.

Num Avgs

2

Filter Risetime 1.000ns

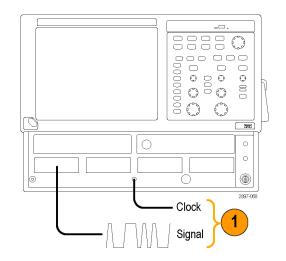
al÷

Display a Communication Signal

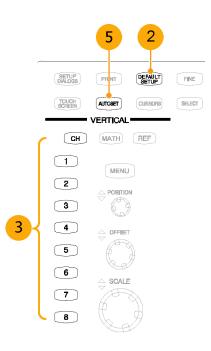
 Connect signals to the sampling module (Data signal to the module input, clock signal to the CLOCK INPUT/PRESCALER TRIGGER connector).



CAUTION. Always observe optical cable and static-safe procedures and cautions as outlined in your sampling-module user manual when connecting cables to modules.



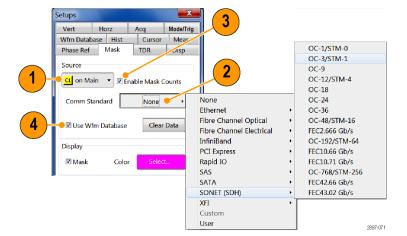
- 2. Push the **DEFAULT SETUP** front panel button and click YES to load the default instrument setup.
- **3.** Select the input signal source (1–8).
- 4. Select Setup > Horizontal and enter the communications standard or set the bit rate of the signal.
- 5. Push the AUTOSET front panel button. The instrument analyses and displays the signal.



Mask Testing

Use mask testing to test your waveforms for time or amplitude violations against a predefined industry standard or a user-defined mask. Mask testing counts waveform samples (called hits or violations) that occur inside of a specific area (the mask). This instrument provides many predefined standard masks (including Ethernet, SONET/SDH, and Fiber Channel (Optical and Electrical)). You can also use the mask edit tools to create a custom mask.

- 1. Select the waveform to be mask tested from the drop-down list under Source.
- Select a standard mask in the Mask setup dialog box. Selecting a communication standard or user-defined mask automatically:
 - Displays the mask on screen and autosets for the mask if Automatic is checked in the dialog box.
 - Enables mask testing.
 - Displays mask count statistics in the mask readout. You do not have to display a mask to enable mask counting.
- If you want, disable mask counts. (Selecting a mask in step 2 automatically enabled them.)
- 4. Check Use Wfm Database to use a waveform database as the waveform source.
- 5. You can enable margins to explore design margins of your communications signal.





To autoset the waveform to the mask:

- Click the Autoset button to perform a manual autoset on the mask-source waveform.
- Select the HiLow Method to determine the signal High and Low values, used to align the input signal to the mask:

NOTE. When using a standard mask, the instrument automatically selects the appropriate HiLow Method.

Mean sets the Mask Autoset to use the mean value of the High level (topline) and Low level (baseline), taken within the fixed eye aperture (center 20% of the eye), to align the input signal to the NRZ mask.

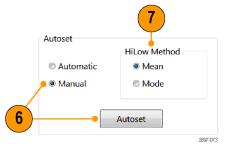
Mode sets the Mask Autoset to use the High level (topline) and Low level (baseline), taken across one unit interval of the eye diagram, to align the input signal to the NRZ mask.

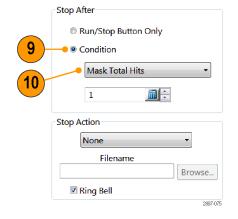
To set a Stop Action:

- Select Setup > Acquire in the main menu to open the Acq setup dialog box.
- 9. In the Acq Setup dialog box, check the Condition option under Stop After.
- In the Condition pulldown list, select a mask-related criteria, such as Mask Total Hits and set a count, such as 1, in the count box.

These settings stop acquisition when mask violations satisfy the criteria you set.

11. Push the **RUN/STOP** button to restart acquisition, if stopped.

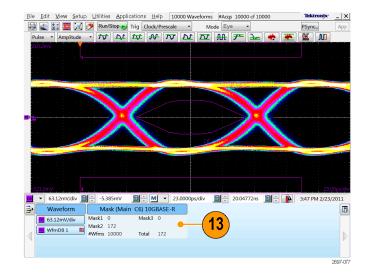






To restart testing:

- To restart after a Stop After condition occurs, push the front-panel CLEAR DATA button, followed by the RUN/STOP front-panel button.
- **13.** Read the mask-hits count in the readout.



Quick Tips

- Selecting a source that is currently displayed as a waveform database automatically enables mask testing on the database. To mask test the waveform instead of its database, deselect the Use Wfm Database box.
- You can choose to autoset the mask-source waveform to the mask each time you select a new mask standard by checking Automatic under Autoset.
- Pushing the RUN/STOP button after acquisition has stopped due to a Stop After condition being met causes the instrument to acquire one (and only one) additional waveform.
- The Clear Data button resets all mask counts. In addition, if the source for mask testing is a waveform database, clicking this button clears the waveform database.

FrameScan

Use FrameScan to test a specific bit (or range of bits) in a repeating frame of data. FrameScan acquisitions allow detailed display and analysis of individual, complete waveforms or of the bit sequences leading up to a failure. This ability to identify the specific patterns that caused the failure makes the FrameScan mode superior to traditional methods.

- 1. Select the Horizontal Setup tab.
- 2. Click Pattern Sync/FrameScan Setup.

			1		
Setups				×	
Wfm Database	Н	ist	Cursor	Meas	
Phase Ref	Mas	sk 🔶	TDR	Disp	
Vere	lorz	•	Acq	Mode/Trig	
Timebase			_		
MainTB			•		
Scale		1.429	bits		
Position		4.64	4bits	a ÷	
Resolution		4.59			
Record Lengt	Record Length Horizontal Reference)	<u>_</u>	
)%	<u></u>	
All Timebases					
Comm Stand	ard		None	•	
	155.	52000	Mbps	.	
Units		. n'i			
© Seconds		Bits Distance			
	Uni	ts Seti	q.		
Display Scale	,				
Per Divisi	ion	Per Screen			
Pattern	Syno	:/Fram	ieScan Setu	ıp	
		Help			
				2897-	

- 3. Click Enabled in FrameScan.
- 4. Set the Scan Bits to the number of bits or subframes to acquire.

attern Sync/FrameScan Setup	
Pattern Sync Control	AutoSync Options
Data Rate	🗹 Data Rate
Pattern Length List	🗹 Pattern Length
Data:Clock Edit	t 🗹 Data:Clock Ratio
Position RTZ	AutoSync to Selected Waveform
Set as New Reference Clock Source	FrameScan Scan Bits ♥ Enabled 64 ■ ◆
Close	Help
	2897-079

To Use TDR

To take TDR measurements, you must have a TDR-capable sampling module installed and your DUT must be attached to the TDR sampling module.

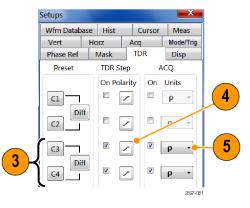
2

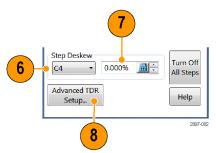
- 1. Select TDR from the Setup menu.
- 2. Click the **channel** button to automatically display the incident and reflected steps of the selected channel by automating the following tasks:
 - Turns on the channel.
 - Turns on a step.
 - Sets trigger source to TDR.
 - Sets acquisition to Averaging.
 - Changes display style to Show Vectors.
- 3. Select a channel pair on which to perform a differential TDR measurement. Click **Diff** to automatically set up the differential measurement for the channel pair.

All the tasks listed in step 2 are performed for both channels and the pulse polarity of the second channel is set to negative.

- 4. Click the polarity button to toggle the step edge.
- 5. Set the vertical scale Units to V (volts), Ω (ohms), or ρ (rho).
- 6. If performing differential TDR, select the channel (TDR module with dual channel adjustment) or the even-numbered channel of the channel pair (TDR module with single channel adjustment) for deskew adjustment.
- 7. Set the Deskew percent value.
- Click TDR Autoset Properties to display the Autoset Properties dialog box to prepare the TDR autoset.

				()		
Setups						×	-	
Wfm Datab	ase	Hist		Curse	r	Meas		
Vert	Ho	rz	Ac	q	Ц	Mode/Tri		
Phase Ref	N	Mask	Т	DR 🤇		Disp		
Preset		TDR Step			ACQ			
		On Pol	Or	n t	Jnits			
	"		~			ρ -		
C2	Π		/			ρ -		
• [3]		▼ [~	V		ρ •		
C4	ff	v (/	V		ρ •		
						289	7-08	





Quick Tips

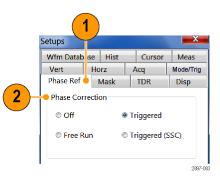
- Use a lower TDR rate to take measurements on long cables.
- For a TDR module with single channel deskew capability, only the even-numbered channel of the module is selectable for deskew. For a TDR module with dual channel deskew capability, both channels of the module are selectable for deskew. (See page 61, Skew and Deskewing.)

Phase Reference

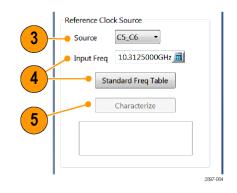
Use the Phase Reference function when you need to minimize instrument trigger jitter. Reducing trigger jitter in the instrument provides better measurement accuracy when measuring clock and other phase-jitter-vulnerable signals.

NOTE. To use the phase reference function, you must have a phase reference module (such as the Tektronix 82A04), and a phase reference clock signal that is synchronous to the data to be acquired and connected to the phase reference module. Refer to the online help for more information on using the phase reference function.

- 1. Select Setup > Phase Ref to display the Phase Reference dialog box.
- Turn Phase Correction on by checking Free Run, Triggered, or Triggered (SSC).
 - Free Run: A trigger is automatically generated. Multi-clock-cycle-period displayed signals are synchronous with the phase reference but overlaid.
 - Triggered: Samples are corrected for horizontal position per the phase reference supplied, but otherwise have all the attributes of a triggered waveform.
 - Triggered (SSC): Phase correction is active and the trigger is used to determine the horizontal acquisition window. The instrument assumes some amount of Spread Spectrum Clocking contained on the phase reference input clock.



- Click the Source control to select the module to which you connected the clock (if more than one phase reference module is installed).
- **4.** Select the input frequency to the phase reference module.
 - Use the Input Freq control to enter the frequency of Phase Reference clock or use the **Standard Freq Table** button to select a communications standard.
- 5. Click the Characterize button to characterize the clock signal attached to the phase reference module.



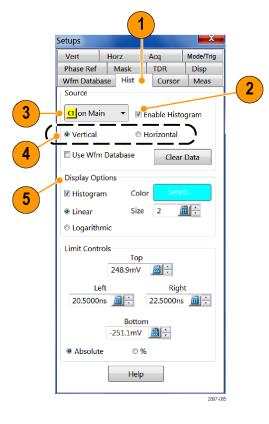
Quick Tips

- When entering the phase reference clock frequency, the value must be within 1% of the actual frequency.
- The instrument accommodates up to approximately 5000 ppm of SSC.

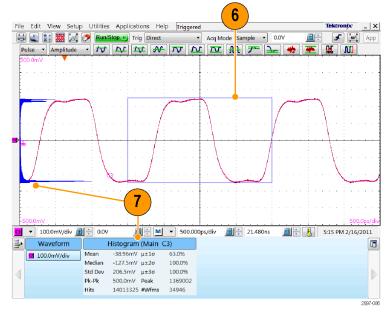
Histograms

The instrument can display histograms constructed of waveform data. You can display both vertical (amplitude) and horizontal (time or distance) histograms, but only one at a time.

- 1. Display the Hist (Histogram) dialog box.
- 2. Check the Enable Histogram box.
- 3. Click the **Source** button to select the waveform source.
- 4. Select a vertical or horizontal histogram.
- **5.** Use the Display Options to change the appearance of the histogram.



- 6. Click and drag the edges of the histogram box to enclose a portion of the waveform.
- 7. The histogram displays at the edge of the graticule. The histogram statistics are displayed in the readout.



Document Your Results

This instrument can save any number of waveforms, limited only by the space you have to store them. By saving a waveform, you can recall it at a later time for comparison, evaluation, and documentation. This capability is helpful when you want to:

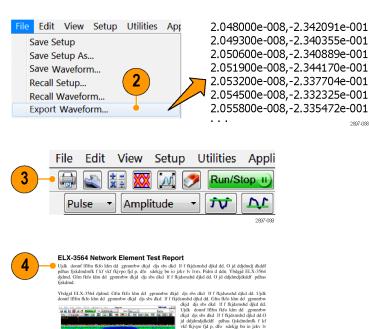
- Recall a waveform for further evaluation or comparison with other waveforms.
- Extend the waveform-carrying capacity of the instrument. The instrument supports eight reference, eight channel, and eight math waveforms. If you want more than eight reference waveforms, you can save the additional reference waveforms to disk for recall later.

Save Setup

Save Setup As... Save Waveform... Recall Setup... Recall Waveform ... Export Waveform ...

le Edit View Setup Utilities App

- 1. To Save a setup or a waveform, click Save Setup or Save Waveform in the File menu.
- 2. To export waveform data, click Export Waveform in the File menu.
- 3. To print a hard copy to an attached printer or a network printer, click the print icon in the toolbar.
- 4. To copy a screen image into another application, choose the Print to file option in the print dialog box. Save the screen image in a format that is compatible with your application, and then insert the screen image into your document.



2897-08





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Uidnd peifnm ELX-3564

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2897-086

Skew and Deskewing

The propagation delay inherent in connecting cables and probes can result in inaccurate amplitude and time-correlated measurements. This is caused by the difference between two or more delays, known as skew. Skew can be present in multi-channel applications, and is of particular concern in differential systems. To obtain the best measurement and analysis results from your instrument, you will need to remove skew, a process known as deskewing.

In differential (non-TDR) applications, skew can occur in acquired signals as they propagate from their source to the mainframe. In TDR applications, skew can occur in signals that propagate from the instrument to the device or system under test (DUT), specifically the TDR stimulus pulses, as well as from acquired signals.

The following procedures and examples explain how to minimize and measure skew in non-TDR and TDR systems.

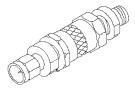
Quick Tips

- Minimize skew by using balanced cable pairs.
- Measure and match your cables. TDR modules such as 80E10, 80E08, and 80E04 allow you to measure cable delays with very high precision.
- In differential systems, use differential probes or differential SMA to single-ended active convertors, such as the Tektronix P7380SMA.

Methods to Adjust Skew

Using a Phase Adjuster

Skew can be adjusted with the use of a variable delay line (phase adjuster). Tektronix part number 015-0708-00 is a phase adjuster with a 25 ps range and VSWR of 1.3:1 at 18 GHz. The advantage of a phase adjuster is that it is functionally invisible. The disadvantage is that signal fidelity is slightly impacted.



Channel Deskew and Channel Delay

To ensure that random, differential, or common-mode signals can be properly time aligned, the DSA8300 allows the skew to be adjusted between individual modules by way of independent acquisition timebases (not available in phase reference mode). This is referred to as channel deskew. In addition, some modules (the 80E06, 80E07, 80E08, 80E09, and 80E10) contain an additional, and highly useful, skew adjustment capability called channel delay.

While both deskew and delay allow you to compensate individual channels for skew differences introduced externally from the instrument, they are implemented differently. Deskew is applied to the strobe drive of the module that is common to both channels in the module. When the deskew values differ between the channels, the instrument automatically performs separate acquisitions for each channel (on different sets of triggers) in order to satisfy the requested deskew difference. Delay is applied only to an individual channel in the module. Therefore, to retain maximum performance, keep the deskew values for both channels in a single sampling module the same and use the delay control if possible.

Channel deskew can be used for repetitive signals. Data is captured with the timebase skew adjusted for each channel, one at a time. This method of skew adjustment relies on the fact that your signals are completely repetitive relative to the trigger of your sampling oscilloscope. If, for each trigger, there is always the same signal, the oscilloscope can adjust the skew using channel deskew. The number of triggers needed to fill the trace doubles relative to an undeskewed acquisition system. More optimal performance can be obtained using multiple modules or modules with channel delay capability.

Random signals are signals that do not necessarily repeat on equivalent trigger events from acquisition to acquisition. The oscilloscope must acquire each waveform sample of both differential branches from exactly the same trigger event. Otherwise, due to the random nature of the signal, one of the samples of the differential pair may have changed value (from an absolute, real-time perspective) and will yield incorrect results of the mathematical differential or common mode waveform.

Setup Considerations and Procedures

Before starting, there are two setup choices to be made. These are explained in the following sections.

Reference Plane

This is the location at which you ultimately want both the acquisition signals and TDR steps (if you are using TDR) to be time aligned. (See Figure 1 on page 63.) Common choices for the reference plane include:

- The instrument front panel
- The inputs to a DUT (Device Under Test) attached to cables
- The inputs to a DUT within a fixture

For best results, select the reference plane at the DUT interface. If it is not possible to inject the signal source at the desired reference plane, ensure that the signal paths for each of the differential signals are precisely matched between the DUT and the selected reference plane.

If you are using the 80A05 Clock Recovery Module and routing your differential signals through this module to an acquisition module, you must leave the 80A05 connected during the deskew procedure. This ensures that any skew introduced by the 80A05 or the connecting cables are accounted for by the deskew procedure.

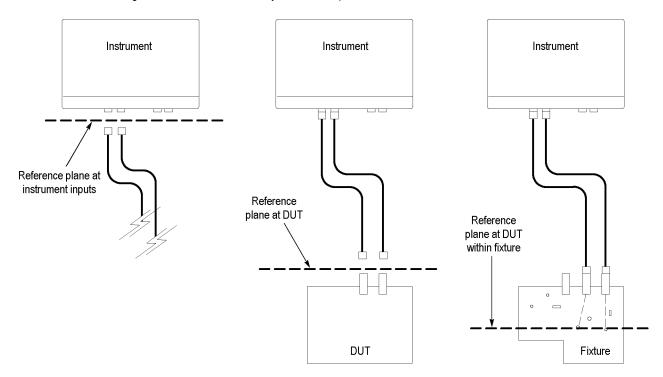


Figure 1: Schematic diagram of reference planes in relation to signal

Acquisition Deskew Signal Sources

There are three possible signals that may be used as a source to be connected to, or "injected" into, the reference plane.

- A TDR step from an extra (unused) TDR-capable module channel (recommended source)
- A stable, fast-edge, low-repetition rate signal that is synchronous to an external trigger source
- The TDR CLOCK OUT signal from the instrument front panel

The TDR step source is preferred because it provides a fast, stable edge at a low repetition rate that is ideal for deskewing signal paths. The low repetition rate signal should have a repetition rate much lower than the amount of skew that needs to be removed so that the relative skew between signals can be correctly determined.

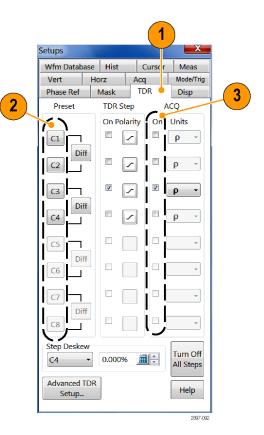
The following are three procedures to set up your instrument in preparation to perform an Acquisition Deskew. Choose the procedure related to the signal source you are using.

TDR Step Source

- 1. Display the TDR setup dialog box by selecting TDR from the Setup menu.
- 2. Turn on the step by clicking the Preset button for the source channel. This will turn on the step and set other scope parameters (such as trigger source) in preparation for making measurements.

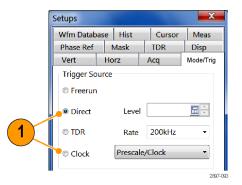
NOTE. Use only the rising edge polarity. Autoset in this mode will not find a negative-going edge.

- Turn off the display of the channel by unchecking the ACQ On box for the source channel. This channel does not need to be displayed.
- Connect a cable or TDR probe to the source channel to use for injecting the TDR step signal into the reference plane.



External Signal

- 1. Set the trigger source to **Direct** or **Clock** [**Prescale/Clock**] as appropriate for the bandwidth of the trigger signal.
- Connect the trigger signal to the appropriate mainframe input (TRIGGER DIRECT INPUT or CLOCK INPUT/PRESCALE TRIGGER).
- 3. Connect a cable or TDR probe to the low-repetition source signal that is synchronous with the trigger signal to use for injecting the signal into the reference plane.



TDR CLOCK OUT

- 1. Set the trigger source to TDR.
- 2. Connect a cable or TDR probe from the TDR CLOCK OUT connector on the front panel of the mainframe to the reference plane of the DUT.

NOTE. You may need to use a 50 Ω terminated SMA T, a 50 Ω terminated power divider, or a 2 – 6 dB attenuator on the TDR CLOCK OUT connector to reduce the amplitude to an acceptable amplitude for the module.

	Setups						×
	Wfm Databa	ase	Hist		Cursor	N	deas
	Phase Ref		Mask		TDR	D	lisp
	Vert	Ho	orz	A	Acq	Mo	de/Trig
	Trigger So	urce					
	© Freerun						
	Direct		Level				* *
1)-	🔶 🖲 TDR		Rate		200kHz		•
	© Clock		Prescal	e/(Clock		•
							2907

For fixture or DUT locations that do not support a cable attachment, the acquisition deskew signal can be injected by a P8018 single-ended TDR probe.

Acquisition Deskew Procedure

The following procedure outlines a method to deskew a single differential (or common) mode system (one signal pair). The procedure can be extended to additional signal pairs as needed. This method time aligns the acquisition system such that the data is acquired simultaneously at the selected reference plane. The procedure accounts for delay mismatches between the differential signal lines from the reference plane to the acquisition inputs.

Autoset Properties

Period

Edge

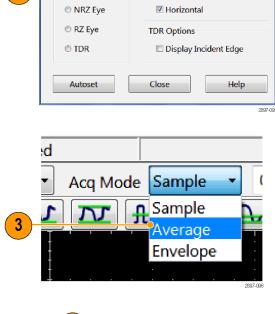
Mode

2

The following example procedure uses Ch3 as the + channel and Ch4 as the – channel.

- Using the previous discussions on deskew signal types and reference planes, inject your selected source signal at the selected reference plane for the + channel. Turn Ch3 on.
- Select Utilities > Autoset Properties. Choose Edge Mode then click the Autoset button to autoset the signal. Click Close to close the dialog box.
- Click on the Acq Mode drop down control and choose Average to enable acquisition averaging.

 Click the Define Math button on the tool bar or push the Math front panel button to display the Define Math dialog box.



Options

Trigger

Vertical

X

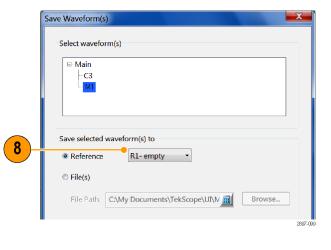


- **5.** Create the following math expression using the buttons in the dialog: Filter(C3).
- **6.** Set the Filter Risetime to a value that is less than half the risetime of the source signal.
- **7.** Check the On box to display the math waveform then close the dialog.

NOTE. At this point, you can dismiss the Ch3 display by pressing the CH button on the front panel and then push the 3 button.

		Math Expression									
		Filter(C	Filter(C3)								
Functions				Sourc	es						
Intg(Diff(Vmag(Filter(C1	C2	C3	C4		+	-	
Exp(Log(Sqrt(Ln(C5	C6	C7	C8		6	7	8
Versus	Avg(Min(Max(R1	R2	R3	R4		2	3	4
				R5	R6	R7	R8		1	0	
	Num	-		Meas	ureme	ent Sc	alars				
Backspace	Filter	Risetime 100.0ps		Meas1		Mea	Meas2		\$3	Mea	s4
Clear	Filter	Mode Ce	entered •	Me	as5	Mea	as6	Meas	57	Mea	s8

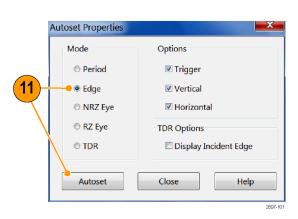
- Select File > Save Waveform. Save M1 into R1 by clicking the Save button. Click Close to dismiss the dialog box. R1 will automatically be displayed.
- **9.** Connect your selected signal source to the channel.



 Display the Define Math dialog box and modify the math expression to use the – channel: Filter(C4). You can use the Backspace button to edit the expression. Click OK to apply the changes and dismiss the dialog box.

10	
Define Math	
Math Waveform	Math Expression
M1 🔻 🛛 On 🔶	Filter(C4)
	2897-100

11. Select Utilities > Autoset Properties. Choose Edge Mode then click the Autoset button to autoset the signal. Click Close to close the dialog box.



- 12. Click Setup > Measurement to open the Measurement Setup tab.
- Click the Select Meas button and select the Pulse - Timing > Delay measurement. Set Source 1 to R1 and Source 2 to M1.
- 14. Using the previous discussion on Methods to Adjust Skew, adjust the skew by changing the Delay or Deskew value for C4 or by changing the external phase adjustor until the measurement reads near zero.

Phase Ref	Mask	TDR	Disp					
Vert H	lorz	Acq	Mode/Trig					
Wfm Database	Hist	Cursor	Meas	(12)				
Meas 1	▼ Or	n	B					
- Pulse Me	asureme	nts						
None								
Pulse - A	mplitude	•						
Pulse - T	iming	•	Rise Time	e				
Pulse - A	rea	۲	Fall Time					
Source1	Source	2 Set t	Period					
			Frequence	y				
Source Reg	gion HiLo	ow RefLe	+ Cross					
			- Cross					
M1 on Mair	n 🕶	+ Width						
			- Width					
			+ Duty C	.ycle				
🔳 Use Wfm	Database	Cl	- Duty C	ycle				
Signal Typ	e		Burst Wi	dth				
Pulse	- NRZ	R	RMS Jitte	er				
J.	XX		Pk-Pk Jit	Pk-Pk Jitter				
00			Delay					
L			Phase					
Statistics	Mainh	ting						
Statistics	Weigh	ung						

13

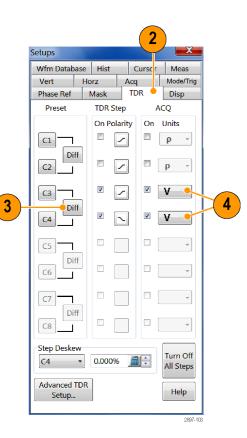
TDR Step Deskew Procedure

TDR Step Deskew time aligns the TDR steps such that the stimulus steps arrive at the selected reference plane at precisely the same time. This procedure requires that an Acquisition Deskew be performed first so that the acquisition channels are properly aligned. It is important that the same reference plane be used for both the Acquisition Deskew and the TDR Step Deskew procedures to avoid possible misalignment of the signals.

1. Ensure that either an open or a short is present at the reference plane for the TDR channels to be deskewed. For best results, both channels should have the same termination.

NOTE. Before proceeding, be sure to set the polarity of the TDR steps to match the step polarities of your application if they are different than the defaults used here (for example, if you are using a common mode measurement).

- 2. Select Setup > TDR to open the TDR Setup dialog box.
- 3. Click the differential preset button for the measurement channels. The TDR preset sets the odd channel to a positive step and the even channel to a negative step. In this procedure, we will use Ch3 and Ch4 as the positive and negative channels.
- 4. Change the units for both channels to V (Volts), then dismiss the dialog box.

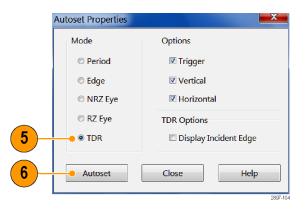


- Select Utilities > Autoset Properties to display the Autoset Properties dialog box. Choose TDR Mode and clear the Display Incident Edge check box.
- 6. Perform an autoset by clicking the Autoset button in the dialog box then dismiss the dialog box.

a. Given reasonably matched paths to the DUT, both reflected edges should be displayed near the 3rd horizontal graticule. If not, increase the Horizontal Scale until both reflected edges are displayed on the screen.

b. Adjust Horizontal Scale (and Position, if necessary), such that the two reflected edges are visible and apart from each other in order to obtain good horizontal resolution. A 10 to 1000 ps/div horizontal scale is a typical target.

- Click the Define Math button on the tool bar or push the Math button on the front panel to display the Define Math dialog box.
- Create the math expression Filter(C3) for M1.
- **9.** Set the Filter Risetime to a value that is less than half the risetime of the reflected TDR step.
- **10.** Check the **On** box to display the math waveform.
- 11. Click Apply.
- Select M2 from the Math Waveform area and create a math expression Filter(C4) for the – channel. Set the Filter Risetime to a value that is less than half the risetime of the reflected TDR step. Select the On box to display the math waveform. Dismiss the dialog box.



Define Math Math Wave			xpression 3)									
Functions				Sourc	es							
Intg(Diff(Vmag(Filter(C1	C2	C3	C4		+	-	*][
Exp(Log(Sqrt(Ln(C5	C6	C7	C8		6	7	8	
Versus	Avg(Min(Max(R1	R2	R3	R4		2	3	4	
	Num	÷ 00.0ps≑	Measurement Scalars									
Backspa	ce Filter	Risetime 1	oo.ops 📷 🗸	Me	as1	Mea	is2	Me	eas3	Mea	s4	
Clear	Filter	Mode Ce	entered •	Me	as5	Mea	as6	Me	eas7	Mea	s8	
	ОК	A	pply	Cancel			He	р				

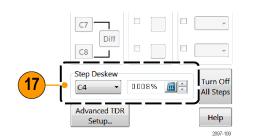


13. Display the Measurement Setup dialog X Setups box by choosing Measurement from the Phase Ref Mask TDR Disp Setup menu. Vert Horz Acq Mode/Trig 13 Meas 🧃 Wfm Database Hist Cursor 14. Click the Select Meas button and select 👻 🗹 On ā Meas 1 Pulse-Timing > Delay. 14 Pulse Measurements None Pulse - Amplitude ۶ Pulse - Timing **Rise Time** Fall Time Pulse - Area Source1 Source2 Period Set t Frequency Source Region HiLow RefLe + Cross - Cross MI on Main 👻 + Width - Width + Duty Cycle - Duty Cycle Use Wfm Database C Burst Width Signal Type **RMS** Jitter Pulse NRZ R Pk-Pk Jitter Λ. XX Delay Phase Statistics Weighting Î Î Annotations Help 2897-107 15. Click the Source 1 button and do the 15 following: a. Click the Source tab and set Source Source1 Source2 Set to Default 1 to **M1**. b. Click the Region tab and set the b а Referrel Source Region ++:Low Slope to +/-. Gates 0.00% 20.75ns G1 23.96ns 100.00% G2 🛛 On Edges Slope • +/-• + 0 📃 ◎ ← Direction • -

2897-108

- 16. Click the Source 2 button and do the 16 following: a. Click the Source tab and set Source Set to Default Source2 Source1 1 to **M2**. b. Click the Region tab and set the b а Source Region etiles RefLevel Slope to +/-. Gates G1 0.00% 20.75ns 100.00% 23.96ns G2 🗷 On Edges Slope ۲ \bigcirc + 0 -Direction -
- 17. Open the Setups dialog box and click the TDR tab. Use the Step Deskew area to select which channel you want to adjust for deskew. Adjust the Step Deskew value until the measurement reads near zero.

NOTE. For future use with the same configuration (such as instrument, modules, cables, and/or fixtures), save the setup by selecting **File > Save Setup As** from the menu bar.



Cleaning the Instrument

Periodically you may need to clean the exterior of your instrument. To do so, follow the instructions in this section.



WARNING. Before performing any procedure that follows, power down the instrument and disconnect it from line voltage.

Exterior Cleaning



CAUTION. To prevent getting moisture inside the instrument during external cleaning, use only enough liquid to dampen the cloth or applicator.

Clean the exterior surfaces of the chassis with a dry lint-free cloth or a soft-bristle brush. If any dirt remains, use a cloth or swab dipped in a 75% isopropyl alcohol solution. Use a swab to clean narrow spaces around controls and connectors. Do not use abrasive compounds on any part of the chassis, as they may damage it.



CAUTION. Avoid the use of chemical cleaning agents, which might damage the plastics used in this instrument. Use a 75% isopropyl alcohol solution as a cleaner and wipe with a clean cloth dampened with deionized water. (Use only deionized water when cleaning the menu buttons or front-panel buttons.) Before using any other type of cleaner, consult your Tektronix Service Center or representative.

Flat Panel Display Cleaning

The instrument display is a soft plastic display and must be treated with care during cleaning.



CAUTION. Improper cleaning agents or methods can damage the flat panel display. Avoid using abrasive cleaners or commercial glass cleaners to clean the display surface. Avoid spraying liquids directly on the display surface or scrubbing it with excessive force.

Clean the flat panel display surface by gently rubbing the display with a clean-room wipe (such as Wypall Medium Duty Wipes, #05701, available from Kimberly-Clark Corporation).

If the display is very dirty, moisten the wipe with distilled water or a 75% isopropyl alcohol solution and gently wipe the display surface. Avoid using excess force or you may damage the plastic display surface.

Optical Connector Cleaning

Keep the optical module connectors clean to maintain measurement accuracy. The optical module user manual contains the procedures for cleaning optical connectors.

Restoring the Operating System

You can restore the Microsoft Windows 7 operating system (OS) in the event that the operating system will not start when powering on the instrument.



CAUTION. The restore process reformats the hard drive and reinstalls the operating system. All data on the disk is lost. If possible, save important files to external media before you perform an operating system restore.

You will need to reinstall the TekScope application if you restore the OS from the DVD recovery media. You will not need to reinstall the TekScope application if you restore from the instrument hard drive.

Restoring the Operating System from the Instrument Hard Disk Drive

These instruments contain an operating system restore file on a separate partition of the hard disk drive.

NOTE. This restore method reinstalls the operating system and the TekScope application software and drivers.

1. Restart the instrument. During the boot-up process you will see the following message in the center of the screen:

Starting Acronis Loader... press F5 for Acronis Startup Recovery Manager

- 2. Repeatedly press the keyboard F5 key until the Acronis True Image Tool opens. There is a three-second time period from when the message appears until the instrument proceeds with the normal instrument startup. If the instrument does not open the Acronis application, power off the instrument, then power on the instrument and try again.
- 3. Click Restore.
- 4. In the Confirmation dialog box, click **Yes** to restore the instrument operating system, or **No** to exit the restore process. The restore process takes approximately 30 minutes; the actual time depends on the instrument configuration.

Restoring the Operating System with Restore Media

NOTE. This procedure requires that the DVD drive is set as the first boot device (this is the default setting).

NOTE. You can only use restore discs on the instrument for which they were created.

- 1. Insert the OS recovery media DVD disc 1 in the instrument DVD drive.
- Restart the instrument. The restore software opens automatically if the DVD drive is the first bootable device. If the DVD drive is not the first bootable device you will need to enable it as the first bootable device before performing a restore from the DVD disc.
- 3. Click Restore.
- 4. In the Confirmation dialog box, click **Yes** to restore the operating system, or **No** to exit the restore process. Follow on screen instructions. You will need to swap DVD 1 and DVD 2 as instructed.
- 5. When the restore process is completed, remove the disc and restart the instrument. The instrument will open into the operating system, settings, and appearance as shipped from the factory.
- 6. Proceed to restoring the TekScope product software and any additional applications. Follow the installation instructions that shipped with the DSA8300 Application Install CD.

Index

A

Accessories, 3 Acquisition set Stop mode & action, 30 Acquisition modes how to set, 30 Annotations, 44 show, 42 Automatic measurements how to localize (gates), 43 Autoset, 28

С

Channel delay, 62 Channel deskew, 62 Characterize phase correction, 58 Cleaning instrument exterior. 73 instrument, how to, 73 Cleaning and inspection flat panel display, 73 Cleaning optical connectors, 73 Communication signal, 49 signal:mask testing, 51 Compensation, 20 how to perform, 20 Compensation indicator, 14 Compliance information, v EMC, v Safety, vii Computer I/O panel, 13 Control panel, 10 Control panel map, 11 Controls bar. 14 Cursor measurements, 46 Cursors H Bars, 46 V Bars, 46

D

Dark-level compensation how to perform, 23 Default setup, 27 Deskew, 61 acquisition deskew, 66 reference plane, 62 signal sources, 63 TDR step, 69 Diagnostics, 18 Dimensions, 4 Display map - main & mag views, 16 map - main view, 15 Display map, 15 Display style normal. 33 show vectors. 33 Document results, 60 Documentation, x Dual monitor, 7

E

Enable histogram, 59 Environmental specifications, 4 Environmental considerations, ix Export waveform, 60 Extended desktop, 7

F

Features, 1 Flat panel display cleaning, 73 Frame Scan, 54 Front panel connectors, 10

G

Graticule color, 34 style, 34

Η

H Bars cursor, 46, 47 Histogram enable, 59 statistics, 59 Histograms, 59 Horizontal set up procedure, 25

Incoming inspection, 18 Input connectors specifications, 5 Input frequency, 58 Inspection and cleaning flat panel display, 73 Installation, 3 Installation, 3 Installing modules, 6 Instrument cleaning, 73 restore, 74 Interface map, 14

Κ

Key features, 1

L

Linear interpolation, 33

М

Map waveform display, 15 Mask testing, 51 autoset to a mask, 52 stopping acquisition based on, 52 Math editor, 48 waveform, 48 Measurement accuracy optimizing, 20 Measurement bar, 14 Measurement readouts, 14 Measurements, 41 cursor, 46 how to localize (gates), 43 turning off, 45 Mechanical specifications, 4 Menu bar, 14

Ν

Normal display style, 33

0

Online help, 17 displaying control descriptions, 17 displaying overviews, 17 using the finder, 17 Operating specifications, 4 Operating system restore, 74

Ρ

Phase correction, 57, 58 input frequency, 58 Phase reference, 57 Power supply specifications, 5 Print, 60 Procedure to compensate the instrument and modules, 20 to localize a measurement, 43 to perform acquisition deskew, 66 to perform dark-level and user wavelength gain compensations, 23 to perform TDR step deskew, 69 to set acquisition modes, 30 to set up the signal input, 25

R

Readout bar, 14

Readouts display, 14 Rear panel connectors, 12, 13 Related documentation, x Restore instrument OS, how to, 74

S

Safety Summary, iii Save setup, 60 waveform, 60 Serial mask testing, 51 Setup save, 60 Setup boxes, 29 Show vectors, 33 Signal communication, 49 Sin(x)/x interpolation, 33 Single sequence, 30 Skew, 61 adjusting, 62 Specifications environmental. 4 input connectors, 5 mechanical. 4 operating, 4 power supply, 5 Spread Spectrum Clocking, 57 SSC, 57 Start an acquisition, 30 Statistics histogram, 59 Status bar, 14 Stop an acquisition, 30

Т

TDR, 55 Temperature compensation, 20 Tool bar, 14 Trigger concepts, 35 event, 35 slope, 35

U

User interface, 14 User wavelength compensation how to perform, 23

V

V Bars cursor, 46 Variable Persistence, 33 Vertical set up procedure, 25 View main & mag, 16

W

Waveform display style, 33 export, 60 save, 60 Waveform bar, 14 Waveform cursors, 46, 47